

The Torsional Quartz-Crystal Viscometer

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Abstract

A complete theoretical analysis of the fluid and solid dynamics of the torsional quartz crystal viscometer is presented which for the first time, establishes a firm theoretical basis for two working equations whereby the viscosity of a fluid may be determined from measurements of the resonant frequency of the crystal and the width of the resonance when immersed in the fluid. Modern instrumentation means that it is possible to achieve higher resolution in the measurement of these two quantities than hitherto and the new theory opens the way to securing a concomitant accuracy in the determination of viscosity.

Keywords Torsional-crystal · Theory · Viscometer · Working equations

1 Introduction

The use of quartz-crystal devices for the measurement of the viscosity of fluids has a long tradition. The systematic study of such devices was begun by Mason [1–3] in the 1940's. He, and others [4–7] reported applications of a variety of devices to the task over a period of 20 years with both the theory and the instrumentation of the devices becoming increasingly sophisticated. Gradually, one device emerged as superior to others for measurements of the viscosity of a range of fluids and that was the torsional quartz-crystal viscometer which was adopted by those with an interest in the properties of fluids rather than those interested in the devices themselves or those seeking applications for quartz transducers. The advantages of the piezoelectric material quartz for these devices were its ready availability and the extensive expertise for its preparation as a viscosity sensor among those who sought applications for quartz crystals. Among the early adopters of the technique interested in the thermophysical properties of fluids were Collings and McLaughlin at Imperial College in London [8], the National Bureau of Standards in Boulder USA, specifically

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Diller [9] and then Haynes, Laesecke and their colleagues [10–12]. Other notable early users were De Bock and others [13], D'yachenko in the Soviet Union [14] and Barlow and his colleagues [15]. More recently the device has been employed by Meier and his colleagues for high-precision measurements on a series of fluids [16–18].

For reasons probably connected with its origins, the detailed mechanical and fluid dynamic theory of the device and the conditions within which its operation should be constrained were never fully explored. Rather, the device was treated as a generic oscillator that was loaded by a viscous fluid with non-zero density to produce a more highly damped oscillation whose bandwidth reflected a combination of these two properties. This led investigators to adopt a working equation for the viscometer based upon bandwidth measurements alone and empirically to study the conditions under which it could be employed successfully [8–18].

The precision with which it is now possible to measure the resonant frequency of oscillators means that there is interest in seeking to exploit additionally an equation based upon the effect of viscosity on the resonant frequency of the oscillator. On the one hand this gives another means of deriving the fluid viscosity from measurements on the same sensor and, on the other hand, it allows the opportunity for an examination of the premise that the device operates in accord with the theoretical description of it. This was not hitherto possible.

In this paper we present a rigorous analysis of solid and fluid dynamics for the torsional quartz-crystal viscometer and derive two working equations for its application. The conditions under which these working equations should be valid are established to guide design of the instrument. Subsequently, in Part II of this paper [19], we employ original experimental data acquired in several different viscometers of this type to examine the extent to which existing instruments conform to the theory.

2 Physical Model of the Viscometer

The torsional quartz-crystal viscometer consists of an X-cut right-circular cylinder of radius R and length L and of density ρ_c , with elastic constants $c_{11}, c_{12}, c_{13}, c_{14}, c_{33}$ and c_{44} as well as piezoelectric constants d_{11} and d_{14} and permittivities ε_1 and ε_3 . The crystal is forced to vibrate torsionally at a (radian) frequency ω with angular amplitude ε . The crystal is suspended by a mechanism which exerts no force upon it other than to oppose gravity and is immersed in an incompressible Newtonian fluid of viscosity μ and density ρ .

A diagram of the quartz crystal is contained in Fig. 1, which also illustrates the coordinate system that we shall employ and indicates the positions of the four electrodes used to excite motion. In order to build a mathematical model of the crystal oscillations we employ a right-handed coordinate system. For a quartz crystal, rectangular coordinates $\{X,Y,Z\}$ are conventionally used such that the X-direction is aligned along the binary axis of the crystal and the Z-direction is aligned along its trigonal axis. An X-cut quartz cylinder is one such that the X-direction is aligned with the axis of the cylinder. It is also appropriate to use a system of cylindrical polar coordinates $\{r, \theta, z\}$ with its origin at the center of the one end of the cylinder



and the *z*-direction aligned along its axis towards its other end. Thus z = X and it is convenient to let r = Y when $\theta = 0$ so r = Z when $\theta = \pi/2$.

The electric field that is applied to force torsional vibrations of the crystal has been contrived by a variety of mechanisms [8–18]. In one scheme, it is induced by four electrodes plated along the length of the surface of the crystal. The first electrode is in the quadrant $\Phi < \theta < \Phi + \pi/2$, the second in $\Phi + \pi/2 < \theta < \Phi + \pi$, the third in $\Phi + \pi < \theta < \Phi + 3\pi/2$, and the fourth in $\Phi + 3\pi/2 < \theta < \Phi + 2\pi$. Here, Φ is the

angle about the z-axis through which the crystal is twisted: $\boldsymbol{\Phi}$ has the same sense as $\boldsymbol{\theta}$ and is of the form

$$\boldsymbol{\Phi}(z,t) = \boldsymbol{\varepsilon}(z) \exp(i\omega t) \tag{1}$$

where $i = \sqrt{(-1)}$ and t denotes time. Note that the quadrants spanned by the electrodes depend on Φ because the electrodes twist with the crystal. The first and third electrodes are at a potential $+V_0 \exp(i\omega t)$ and the second & fourth at a potential $-V_0 \exp(i\omega t)$. Electrical connections are made to the electrodes by wires attached at the mid-plane (z = L/2): these wires also serve to support the quartz crystal. Although other methods have been used to generate the forcing electric field the consequences for the analysis that follows are identical.

While in principle, the quartz crystal could be made in a variety of sizes it is typically 50–100 mm long and 5–10 mm in diameter. These dimensions together with the elastic constants of quartz constrain the magnitudes of some of the variables for the instrument and it is useful to summarize them and a variety of quantities that we introduce in the analysis early in the discussion. Thus, Table 1 lists the main quantities of interest and the values they have in a typical instrument. Each quantity is defined in the text. Table 2 lists of some of the dimensionless groups

Quantity	Magnitude	Quantity	Ma	agnitude
<i>R</i> /m	10 ⁻²	$d_{11}/{ m m~V^{-1}}$	3 >	× 10 ⁻¹²
<i>L</i> /m	10^{-1}	d_{14} /m V ⁻¹	7 >	< 10 ⁻¹³
L^*/m	10^{-1}	$d_{\rm typical}/{\rm m~V^{-1}}$	10-	-12
<i>l</i> _r /m	10 ⁻⁷	V_0/V	10	
ε	10 ⁻⁸	$\epsilon \sim d_{\rm typical}$	V_0/R) L/R	
е	10 ⁻³			
ω_{0R} /rad s ⁻¹	2.2×10^{5}			
<i>t</i> */s	1.0			
$\Delta T^*/K$	10^{-2}			
Quartz				
$ ho_{\rm c}/{\rm kg}\cdot{\rm m}^{-3}$	2.6×10^{3}			
Working Fluid	C6 at 0.1 MPa	C6 at 10 MPa	C1 at 0.1 MPa	C1 at 10 MPa
µ/Pa∙s	2.9×10^{-4}	3.2×10^{-4}	1.1×10^{-5}	1.4×10^{-5}
$ ho$ /kg \cdot m ⁻³	6.5×10^{2}	6.6×10^{2}	6.4×10^{-1}	7.5×10^{1}
$(1/\mu) \partial\mu/\partial T /K$	9.0×10^{-3}	8.8×10^{-3}	2.7×10^{-3}	7.2×10^{-4}
<i>∂ρ/∂T</i> / <i>ρ</i> /K	1.5×10^{-3}	1.3×10^{-3}	3.3×10^{-3}	5.7×10^{-3}
<i>∂µ/∂p</i> /µ/Pa	1.2×10^{-8}	1.1×10^{-8}	9.2×10^{-9}	4.5×10^{-8}
$ \partial \rho / \partial p / \rho / Pa$	1.3×10^{-9}	1.7×10^{-9}	1.0×10^{-5}	1.1×10^{-7}
$\lambda/\mathrm{W}\cdot\mathrm{m}^{-1}\cdot K^{-1}$	1.1×10^{-1}	1.2×10^{-1}	3.4×10^{-2}	4.3×10^{-2}
<i>c/</i> m s ⁻¹	1.1×10^{3}	1.1×10^{3}	4.5×10^{2}	4.4×10^{2}

Table 1 Typical values of the design characteristic of a quartz-crystal viscometer and the fluids studied

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Dimensionless Group	Magnitude in practice				Desired values
	C6 at 0.1 MPa	C6 at 10 MPa	C1at 0.1 MPa	C1 at 10 MPa	
з	1.0×10^{-8}	1.0×10^{-8}	1.0×10^{-8}	1.0×10^{-8}	« 1 (Table 1)
R/L	1.0×10^{-1}	1.0×10^{-1}	1.0×10^{-1}	1.0×10^{-1}	« 1 or ~ 1 (Table 1)
$\epsilon R/L$	1.0×10^{-9}	1.0×10^{-9}	1.0×10^{-9}	1.0×10^{-9}	« 1 (Table 1)
$ ho \omega_{0R} \epsilon R^2 / \mu$	4.9×10^{-1}	4.5×10^{-1}	1.3×10^{-2}	1.2	« 1 or ~ 1 Eq. (3)
$\sqrt{\mu/(ho \omega_{0{ m R}}R^2)}$	1.4×10^{-4}	1.5×10^{-4}	8.8×10^{-4}	9.2×10^{-5}	« 1
$1/(t^* \omega_{0\mathrm{R}})$	4.5×10^{-6}	4.5×10^{-6}	4.5×10^{-6}	4.5×10^{-6}	«1 Eq. (241)
$Na = \frac{\omega_{0R}^2 \varepsilon^2 R^2 \partial \mu / \partial T }{\lambda}$	1.1×10^{-14}	1.1×10^{-14}	4.2×10^{-16}	1.1×10^{-16}	« 1 Eq. (34) Equation (251)
$Ma = \omega_{0R} \epsilon R/c$	2.0×10^{-8}	2.0×10^{-8}	4.9×10^{-8}	$5.0 imes 10^{-8}$	«1 Eq. (35)
$\sqrt{(ho\mu/\omega_{0\mathrm{R}})/(ho_c R)}$	3.6×10^{-5}	3.8×10^{-5}	2.2×10^{-7}	2.7×10^{-6}	« 1
e .	1.0×10^{-3}	1.0×10^{-3}	1.0×10^{-3}	1.0×10^{-3}	«1 Eq. (232)
$l_r \sqrt{\rho \; \omega_{0\mathrm{R}}/\mu}$	7.0×10^{-2}	6.7×10^{-2}	1.1×10^{-2}	1.1×10^{-1}	«1 Eq. (235)
R/L^*	1.0×10^{-1}	1.0×10^{-1}	1.0×10^{-1}	1.0×10^{-1}	« 1 or ~ 1 Eq. (236)
$ ho \omega_{0\mathrm{R}}^2 \epsilon^2 R^2 \partial \mu / \partial p / \mu$	3.8×10^{-15}	3.5×10^{-15}	2.8×10^{-18}	1.6×10^{-15}	«1 Eq. (237)
$ ho \omega_{0\mathrm{R}}^* arepsilon^2 R^2 \partial ho / \partial p / ho$	4.1×10^{-16}	5.4×10^{-16}	3.1×10^{-15}	4.0×10^{-15}	«1 Eq. (238)
$(\Delta T^*/\mu) \partial\mu/\partial T $	9.0×10^{-5}	8.8×10^{-5}	2.7×10^{-5}	7.2×10^{-6}	«1 Eq. (239)
$(\Delta T^*/ ho) \partial ho/\partial T $	1.5×10^{-5}	1.3×10^{-5}	3.3×10^{-5}	5.7×10^{-5}	«1 Eq. (240)

Table 2 (continued)					
Dimensionless Group	Magnitude in practice				Desired values
	C6 at 0.1 MPa	C6 at 10 MPa	Clat 0.1 MPa	C1 at 10 MPa	
$\frac{[2R\omega_{0R}/(\pi c)][1-(2/(\rho_c R))}{\sqrt{1/2\rho\mu/\omega_{0R}}(1+(R/L))]}$	1.3	1.3	3.1	3.2	≠n (integer n) Equation (244)
$\frac{[L\omega_{0R}/(\pi c)][1-(2/\rho_c R)]}{\sqrt{1/2\rho\mu/\omega_{0R}}(1+(R/L))]}$	12.7	12.7	31.1	31.8	
$\frac{[L^*\omega_{0R}/(\pi c)][1-(2/(\rho_c R))}{\sqrt{1/2\rho \mu/\omega_{0R}}(1+(R/L))]}$	12.7	12.7	31.1	31.8	

that are important in the analysis, their typical values for a representative instrument and for two fluids of the type that are studied in such instruments. We consider for these purposes an organic fluid with six carbon atoms (C6) and one with one carbon atom (C1) at two different pressures. We include values for the dimensionless groups that the theory developed here uses and the constraints that it places on them for its validity. The latter constraints are expressed as inequalities and the equation or table number that follows each in the column labeled "Desired Value" indicates where they arise in the analytic treatment that follows.

2.1 Fluid Mechanics

We consider the situation in which the crystal is driven into oscillation continuously so that any transients associated with the initiation of oscillation have decayed and it is surrounded by a Newtonian fluid of density ρ and viscosity μ . Then, provided the radial dimension of the region in which there are significant spatial variations of flow variables is much less than the axial dimension of the cylinder and provided the twist on the cylinder varies weakly with axial position, that is, provided $\varepsilon R \ll L$, the flow is planar, so the velocity field **u** and the pressure field *p* do not vary significantly with axial position *z*, and **u** has no *z*-component. Together with axisymmetry, this implies that

$$\mathbf{u} = u_{\theta}(r, t)\mathbf{i}_{\theta}, \quad p = p(r, t)$$
(2)

where \mathbf{i}_{θ} is a unit vector in the θ -direction. The form of Eq. (2) automatically ensures that mass is conserved. Provided that the flow is laminar, which is assured if the Reynolds number $Re = \rho \omega \epsilon R^2 / \mu \ll 1$ or ~ 1 (the latter because the flow is nearly non-accelerating), the momentum conservation equation yields

$$-\rho \frac{u_{\theta}^2}{r} = -\frac{\partial p}{\partial r}$$
(3)

so that $p = p_{\infty} + \rho \int_{\infty}^{r} (u_{\theta}^2/r) dr$ and

$$\rho \frac{\partial u_{\theta}}{\partial t} = \mu \frac{\partial \left(\left(\frac{1}{r} \right) \frac{\partial (r u_{\theta})}{\partial r} \right)}{\partial r}$$
(4)

subject to the boundary conditions

$$u_{\theta} = i\omega \varepsilon R \exp(i\omega t) \text{ at } r = R, u_{\theta} \to 0 \text{ as } r \to \infty$$
(5)

We now introduce dimensionless variables so that

$$u_{\theta} = \omega \varepsilon R \exp(i \omega t) f(\sigma)$$
(6)

where

$$\sigma = r/R.$$
(7)

Equation (4) then becomes

$$\frac{d^2f}{d\sigma^2} + (1/\sigma)\frac{df}{d\sigma} - (1/\sigma^2)f - i\Omega f = 0$$
(8)

with

$$f = i \operatorname{at} \sigma = 1, f \to 0 \operatorname{as} \sigma \to \infty \tag{9}$$

and,

$$\Omega = \frac{\rho \omega R^2}{\mu}.$$
 (10)

The solution of Eq. (8) is

$$f = c_1 \left(\operatorname{ber}_1 \left(\sigma \sqrt{\Omega} \right) + i \operatorname{bei}_1 \left(\sigma \sqrt{\Omega} \right) \right) + c_2 \left(\operatorname{ker}_1 \left(\sigma \sqrt{\Omega} \right) + i \operatorname{kei}_1 \left(\sigma \sqrt{\Omega} \right) \right)$$
(11)

where $\text{ber}_n()$, $\text{bei}_n()$, $\text{ker}_n()$ and $\text{kei}_n()$ are *n*-th order Kelvin functions. It follows from Eq. (9) that

$$c_{1} = 0$$

$$c_{2} = \frac{i}{\left(\ker_{1}\left(\sqrt{\Omega}\right) + i \operatorname{kei}_{1}\left(\sqrt{\Omega}\right)\right)} = \left(\operatorname{kei}_{1}\left(\sqrt{\Omega}\right) + i \operatorname{ker}_{1}\left(\sqrt{\Omega}\right)\right) / \left(\operatorname{ker}_{1}^{2}\left(\sqrt{\Omega}\right) + \operatorname{kei}_{1}^{2}\left(\sqrt{\Omega}\right)\right).$$
(12)

The shear stress $\sigma_{r\theta}$ in the fluid is given by

$$\sigma_{r\theta} = \mu r \frac{\partial (u_{\theta}/r)}{\partial r} = \mu \left(\frac{\partial u_{\theta}}{\partial r} - \frac{u_{\theta}}{r}\right) = \mu \omega \varepsilon \exp(i\omega t) \left(\frac{df}{d\sigma} - \frac{f}{\sigma}\right).$$
(13)

Using the properties of Kelvin functions [20] we find that on the cylinder surface, at r=R ($\sigma=1$)

$$\sigma_{r\theta}|_{R} = \mu\omega\,\varepsilon\,\exp(i\omega t)\left[c_{2}\left(\left(\ker_{0}\left(\sqrt{\Omega}\right) + i\mathrm{kei}_{0}\left(\sqrt{\Omega}\right)\right)\sqrt{\Omega}(i-1)/\sqrt{2}\right) - 2i\right].$$
(14)

Using the values drawn from practical examples of the application of the technique given in Tables 1, $2\sqrt{\Omega} >> 1$ which means physically that there is a very thin shear layer near the surface of the cylinder in which there are significant spatial velocity variations. We also note that $\sqrt{\Omega} >> 1$ implies that the flow is planar.

Again, from the properties of Kelvin functions [20]

$$\ker_n(x) \to +\sqrt{\frac{\pi}{2x}} \exp\left(-\frac{x}{\sqrt{2}}\right) \left[\cos\left(\left(\frac{x}{\sqrt{2}}\right) + \left(\frac{1}{2}n + \frac{1}{8}\right)\pi\right) + O\left(\frac{1}{x}\right)\right] \text{ as } x \to \infty$$
(15)

$$\operatorname{kei}_{n}(x) \to -\sqrt{\frac{\pi}{2x}} \exp\left(-\frac{x}{\sqrt{2}}\right) \left[\sin\left(\left(\frac{x}{\sqrt{2}}\right) + \left(\frac{1}{2}n + \frac{1}{8}\right)\pi\right) + O\left(\frac{1}{x}\right)\right] \text{ as } x \to \infty.$$
(16)

Thus,

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$$\sigma_{r\theta}|_{R} = \mu\omega\varepsilon \exp(i\omega t) \left[-(i-1)\sqrt{\frac{1}{2}\Omega} - 2i + O(1) \right]$$
(17)

or since $\sqrt{\varOmega} >> 1$

$$\sigma_{r\theta}|_{R} = (1-i)\sqrt{\frac{1}{2}\Omega}\,\mu\,\omega\,\varepsilon\,\exp(i\,\omega\,t).$$
(18)

If *d* is the thickness of the shear layer then, because $\sigma_{r\theta}|_R \sim \mu\omega\epsilon R/d$, and from Eq. (18) $\sigma_{r\theta}|_R \sim \mu\omega\epsilon \sqrt{\Omega}$; it follows that $d \sim R/\sqrt{\Omega}$ which shows that the shear layer is indeed thin if $\sqrt{\Omega} >> 1$.

The force *F*' per unit length of cylinder exerted by the fluid on the cylinder is given by $F'=-2\pi R \sigma_{r\theta}|_R$ so the moment, *M'*, per unit length of cylinder exerted by the fluid on the cylinder is given by

$$M' = -2\pi R^2 (1-i) \sqrt{\frac{1}{2}\Omega} \ \mu\omega\varepsilon \ \exp(i\omega t) \tag{19}$$

or

$$M' = \frac{2\pi R^2 \mu}{\omega} \sqrt{\frac{1}{2}\Omega} \left[-\omega^2 \epsilon \exp(i\omega t) + i\omega \epsilon \exp(i\omega t)\omega \right].$$
(20)

But $-\omega^2 \varepsilon \exp(i\omega t)$ is the angular acceleration, $\partial^2 \Phi / \partial t^2$, of the cylinder and $i\omega \varepsilon \exp(i\omega t)$ is its angular velocity, $\partial \Phi / \partial t$ so that we can write

$$M' = k \frac{\partial^2 \Phi}{\partial t^2} + \omega k \frac{\partial \Phi}{\partial t}$$
(21)

where

$$k = 2\pi R^3 \sqrt{\frac{\rho \,\mu}{2\omega}}.\tag{22}$$

For a cylinder of finite length L, as well as the stress on the cylindrical circular surface there is drag at each of its ends (z=0 and z=L). To leading order, the velocity field **u** near the ends has no radial component or axial component and its angular component $u_{\theta}(r, z, t)$ is determined by the solution of

$$\rho \,\frac{\partial u_{\theta}}{\partial t} \,=\, \mu \,\frac{\partial^2 u_{\theta}}{\partial z^2} \tag{23}$$

assuming that velocity variations are confined to a thin shear layer so that gradients with respect to r are insignificant compared with those with respect to z. The boundary conditions after the initial transient on start-up of the flow has decayed are

$$u_{\theta} = i\omega \varepsilon r \exp(i\omega t) at z = 0 \text{ or } z = L, u_{\theta} \to 0 as |z| \to \infty.$$
(24)

If we consider just the end at z = L and write

$$u_{\theta} = \omega \varepsilon \operatorname{rexp}(i\omega t) F(\zeta^*), \qquad \zeta^* = (z-L)/R$$
 (25)

then Eqs. (23) and (24) become

$$\frac{d^2F}{d\zeta^{*2}} - i\,\Omega\,F = 0 \tag{26}$$

$$F = i \operatorname{at} \zeta^* = 0, F \to 0 \operatorname{as} \zeta^* \to \infty.$$
(27)

The solution of Eq. (26) subject to (27) is

$$F = i \exp\left(-\zeta^* \sqrt{i\,\Omega}\right) \tag{28}$$

so that the shear stress, $\sigma_{z\theta} = \mu \frac{\partial u_{\theta}}{\partial z}$ can be shown to be

$$\sigma_{z\theta} = (1-i)\sqrt{\frac{1}{2}\Omega} \ \mu\omega \ \epsilon \ \left(\frac{r}{R}\right) \exp(i\omega t) \exp\left(-\zeta^* \sqrt{i\Omega}\right). \tag{29}$$

Thus, the shear stress $\sigma_{z\theta}|_L$ exerted on the fluid by the end of the cylinder at z=L ($\zeta^*=0$) is given by

$$\sigma_{z\theta}|_{L} = (1-i)\sqrt{\frac{1}{2}\Omega} \ \mu\omega\varepsilon \left(\frac{r}{R}\right) \exp(i\omega t)|_{L}$$
(30)

and the moment $M|_L$ exerted by the fluid on the end of the cylinder is

$$M|_{L} = -\int_{0}^{R} r\sigma_{z\theta}|_{L} 2\pi r \, dr \tag{31}$$

or

$$M|_{L} = -\frac{1}{4} (1-i) k \omega^{2} R \varepsilon|_{L} \exp(i\omega t) = \frac{1}{4} (1+i) k \omega R \left. \frac{\partial \Phi}{\partial t} \right|_{L}$$
(32)

and by symmetry

$$M|_{0} = -\frac{1}{4}(1+i)k\omega R \left. \frac{\partial \Phi}{\partial t} \right|_{0}.$$
(33)

2.2 Effects in the Fluid that Are Rendered Negligible

So far we have considered the major effects of the fluid on the oscillation of the quartz crystal but for completeness of the analysis we need to look at other fluid effects that may affect the operation of any instrument and its accuracy. First, we have so far assumed that the fluid is isothermal throughout and remains at an equilibrium temperature with the crystal. However, in principle, heat generation

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by viscous dissipation causes a local rise in temperature T in the fluid. This rise has a negligible effect on the viscosity of the fluid provided the Nahme number

$$Na = \omega^2 \, \epsilon^2 R^2 |\partial \mu / \partial T| \, /\lambda \ll 1 \tag{34}$$

where λ is the thermal conductivity of the fluid and $|\partial \mu/\partial T|$ is evaluated at the ambient temperature of the fluid. Table 2 shows that in a typical realization of the instrument $Na < 10^{-14}$ so that the condition for the neglect of viscous heating is easily fulfilled.

We have also assumed that the fluid is incompressible for our analysis of fluid flow. Compressibility effects vary as the square of the Mach number

$$Ma = \omega \varepsilon R/c \tag{35}$$

where *c* is the speed of sound and so their neglect is justified so long as $Ma \ll 1$. For practical instruments, Table 2 shows that $Ma < 5 \times 10^{-8}$ so that it is legitimate to treat the fluid as incompressible.

3 Solid Mechanics

We now consider the crystal itself and its response to the fluid behavior surrounding it. The crystal motion is driven by the converse piezoelectric effect which involves application of an electric field to produce a stress. If an electric field, **E** acts on the quartz crystal, the components of the resultant stress field, σ , are related to those of **E** and the strain **e** as follows

$$\sigma_{XX} = c_{11}e_{XX} + c_{12}e_{YY} + c_{13}e_{ZZ} + 2c_{14}e_{YZ} - c_{11}d_{11}E_X + c_{12}d_{11}E_X + c_{14}d_{14}E_X$$
(36)

$$\sigma_{YY} = c_{12}e_{XX} + c_{11}e_{YY} + c_{13}e_{ZZ} - 2c_{14}e_{YZ} - c_{12}d_{11}E_X + c_{11}d_{11}E_X - c_{14}d_{14}E_X$$
(37)

$$\sigma_{ZZ} = c_{13}e_{XX} + c_{13}e_{YY} + c_{33}e_{ZZ}$$
(38)

$$\sigma_{YZ} = c_{14}e_{XX} - c_{14}e_{YY} + 2c_{44}e_{YZ} - 2c_{14}d_{11}E_X + c_{44}d_{14}E_X$$
(39)

$$\sigma_{XZ} = 2c_{44}e_{XZ} + 2c_{14}e_{XY} + c_{44}d_{14}E_Y + 2c_{14}d_{11}E_Y$$
(40)

$$\sigma_{XY} = 2c_{14}e_{XZ} + 2c_{66}e_{XY} + c_{14}d_{14}E_Y + 2c_{66}d_{11}E_Y$$
(41)

where

$$c_{66} = \frac{1}{2} \left(c_{11} - c_{12} \right). \tag{42}$$

The strain components are defined in terms of displacements ξ , η and ζ in the *X*-, *Y*- and *Z*-directions, respectively, as follows

$$e_{XX} = \partial \xi / \partial X, \ e_{YY} = \partial \eta / \partial Y, \ e_{ZZ} = \partial \zeta / \partial Z,$$

$$e_{XY} = \frac{1}{2} ((\partial \eta / \partial X) + (\partial \xi / \partial Y)),$$

$$e_{XZ} = \frac{1}{2} ((\partial \zeta / \partial X) + (\partial \xi / \partial Z)),$$

$$e_{YZ} = \frac{1}{2} ((\partial \zeta / \partial Y) + (\partial \eta / \partial Z)).$$
(43)

The electric field **E** is solenoidal (i.e. $\nabla \cdot \mathbf{E} = 0$) and is given by the negative gradient of the potential $V (\mathbf{E} = -\nabla V)$, so V is harmonic (i.e. it satisfies Laplace's equation: $\nabla^2 V = 0$). If $\epsilon R \ll L$ then **E** is planar; it has no *z*-component and does not vary in the *z*-direction. Thus

$$\left(\left(\frac{\partial (r \,\partial V/\partial r)}{\partial r}\right)/r\right) + \left(\left(\frac{\partial^2 V}{\partial \theta^2}\right)/r^2\right) = 0. \tag{44}$$

For the disposition of electrodes discussed earlier the boundary conditions are

$$V = + V_0 \exp(i\omega t) at r = R \text{ for } \Phi < \theta < \Phi + \pi/2 \text{ and } \Phi + \pi < \theta < \Phi + 3\pi/2$$
$$V = -V_0 \exp(i\omega t) at r = R \text{ for } \Phi + \pi/2 < \theta < \Phi + \pi \text{ and } \Phi + 3\pi/2 < \theta < \Phi + 2\pi$$
(45)

The solution of Eq. (44) subject to (45) is

$$V = (2/\pi) V_0 \exp(i\omega t) \tan^{-1}(4R^2r^2\cos(\theta - \Phi)\sin(\theta - \Phi)/(R^4 - r^4))$$
(46)

or transforming to $\{X, Y, Z\}$ coordinates

$$V = (2/\pi)V_0 \exp(i\omega t) \tan^{-1} \left[\frac{4R^2 (Y\cos \Phi + Z\sin \Phi)(Z\cos \Phi - Y\sin \Phi)}{\left(R^4 - \left(Y^2 + Z^2\right)^2\right)} \right].$$
(47)

But $\cos \Phi = 1$ and $\sin \Phi = 0$ to leading order since $\epsilon \ll 1$ and so

$$V = (2/\pi)V_0 \exp(i\omega t) \tan^{-1} \left[\frac{4R^2 Y Z}{\left(R^4 - \left(Y^2 + Z^2\right)^2\right)} \right]$$
(48)

Here we note that $E_X = -\frac{\partial V}{\partial X} = 0$ and $E_Y = -\frac{\partial V}{\partial Y}$, while $E_Z = -\frac{\partial V}{\partial Z}$ is irrelevant to the stress in the crystal. It then follows from Eqs. (36) to (41) inclusive that the direct effect of the electric field **E** occurs because its *Y*-component, E_Y induces shear strains e_{XZ} and e_{XY} and hence shear stresses σ_{XZ} and σ_{XY} We now assume there is no shear strain in a plane normal to the X-axis so that $e_{YZ} = 0$. Then, $\sigma_{YZ} = 0$ and σ_{XY} and σ_{XZ} are given by

$$\sigma_{XY} = 2 c_{66} e_{XY} + 2 c_{14} e_{XZ} + (2 c_{66} d_{11} + c_{14} d_{14}) E_Y$$

$$\sigma_{XZ} = 2 c_{14} e_{XY} + 2 c_{44} e_{XZ} + (2 c_{14} d_{11} + c_{44} d_{14}) E_Y.$$
(49)

The normal strain components e_{XX} , e_{YY} and e_{ZZ} are not assumed to vanish and in general they do not do so. Thus, the normal stress components σ_{XX} , σ_{YY} and σ_{ZZ} do not vanish either. It follows that it is appropriate to transform from $\{X, Y, Z\}$ coordinates to $\{X, X_1, X_2\}$ coordinates where the X_1 - and X_2 -directions are aligned with the principal axes of the symmetric matrix $\begin{pmatrix} c_{66} & c_{14} \\ c_{14} & c_{44} \end{pmatrix}$ the eigen-values of which are v_1 and v_2 . Then

$$\det \begin{pmatrix} c_{66} - v & c_{14} \\ c_{14} & c_{44} - v \end{pmatrix} = 0$$
(50)

where v is v_1 or v_2 . It follows that

$$v = \frac{1}{2} \left(c_{44} + c_{66} \right) \pm \frac{1}{2} \sqrt{\left(c_{44}^2 + 2 c_{44} c_{66} + c_{66}^2 - 4 c_{44} c_{66} + 4 c_{14}^2 \right)}$$
(51)

and so, arbitrarily assigning v_1 and v_2 and hence the X_1 - and X_2 -directions

$$v_{1} = \frac{1}{2}(c_{44} + c_{66}) + \frac{1}{2}\sqrt{((c_{44} - c_{66})^{2} + 4c_{14}^{2})}$$

$$v_{2} = \frac{1}{2}(c_{44} + c_{66}) - \frac{1}{2}\sqrt{((c_{44} - c_{66})^{2} + 4c_{14}^{2})}$$
(52)

so that

$$v_1 + v_2 = c_{44} + c_{66}, v_1 v_2 = c_{44} c_{66} - c_{14}^2.$$
 (53)

If λ is the angle between the Y- and X₁-directions, and hence also between the Zand X₂-directions, and λ has the same sense as θ then

$$\begin{pmatrix} \cos\lambda & \sin\lambda\\ -\sin\lambda & \cos\lambda \end{pmatrix} \begin{pmatrix} c_{66} & c_{14}\\ c_{14} & c_{44} \end{pmatrix} \begin{pmatrix} \cos\lambda & -\sin\lambda\\ \sin\lambda & \cos\lambda \end{pmatrix} = \begin{pmatrix} v_1 & 0\\ 0 & v_2 \end{pmatrix}.$$
 (54)

The two diagonal components of Eq. (54) merely reproduce Eq. (53); the two offdiagonal components are the same and yield

$$\lambda = \frac{1}{2} \tan^{-1} \left(2 c_{14} / (c_{66} - c_{44}) \right).$$
(55)

For quartz, $c_{14} \approx -18$ GPa, $c_{66} \approx 40$ GPa and $c_{44} \approx 58$ GPa [21] so $\lambda \approx +0.55$ rad.

If ξ , ξ_1 and ξ_2 are the displacements in the *X*-, *X*₁- and *X*₂-directions, respectively, then for torsion through a small angle Φ (i.e. for $\epsilon \ll 1$)

$$\xi = \psi \,\partial\Phi/\partial X, \,\xi_1 = -X_2 \Phi, \,\xi_2 = +X_1 \Phi \tag{56}$$

where Φ is independent of X_1 and X_2 , $\partial \Phi / \partial X$ is the twist and $\psi(X_1, X_2)$ is the torsion function, which accounts for distortion of cross-sections that are planar and normal to the X-axis in the untwisted crystal. Thus

$$e_{XX_1} = \frac{1}{2} \left(\left(\frac{\partial \xi_1}{\partial X} \right) + \left(\frac{\partial \xi}{\partial X_1} \right) \right) = \frac{1}{2} \left(\frac{\partial \Phi}{\partial X} \right) \left(\left(\frac{\partial \psi}{\partial X_1} \right) - X_2 \right)$$
(57)

$$e_{XX_2} = \frac{1}{2} \left(\left(\frac{\partial \xi_2}{\partial X} \right) + \left(\frac{\partial \xi}{\partial X_2} \right) \right) = \frac{1}{2} \left(\frac{\partial \Phi}{\partial X} \right) \left(\left(\frac{\partial \psi}{\partial X_2} \right) + X_1 \right)$$
(58)

and

$$e_{XX} = \frac{\partial \xi}{\partial X} = \psi \frac{\partial^2 \Phi}{\partial X^2} \neq 0.$$
(59)

In the absence of the electric field, when $E_{\gamma} = 0$ then Eqs. (49) yield

$$\sigma_{XX1} = 2 v_1 e_{XX1} \text{ and } \sigma_{XX2} = 2 v_2 e_{XX2}$$
 (60)

on transformation to $\{X, X_1, X_2\}$ coordinates and so, using Eqs. (57) and (58)

$$\sigma_{XX1} = v_1(\partial \Phi/\partial X) \left(\left(\partial \psi/\partial X_1 \right) - X_2 \right) \text{ and } \sigma_{XX2} = v_2(\partial \Phi/\partial X) \left(\left(\partial \psi/\partial X_2 \right) + X_1 \right).$$
(61)

If we now introduce the stress function $\chi(X_1, X_2)$ such that

$$\frac{\partial \chi}{\partial X_2} = + \frac{1}{2} \left(\frac{v_1}{\sqrt{v_1 v_2}} \right) ((\frac{\partial \psi}{\partial X_1}) - X_2) \\ \frac{\partial \chi}{\partial X_1} = - \frac{1}{2} \left(\frac{v_2}{\sqrt{v_1 v_2}} \right) ((\frac{\partial \psi}{\partial X_2}) + X_1)$$
(62)

then it follows that

$$v_1(\partial^2 \chi / \partial X_1^2) + v_2(\partial^2 \chi / \partial X_2^2) = -\sqrt{v_1 v_2}$$
 (63)

and

$$\sigma_{XX_1} = +2\sqrt{\nu_1\nu_2}(\partial\Phi/\partial X)(\partial\chi/\partial X_2)$$

$$\sigma_{XX_2} = -2\sqrt{\nu_1\nu_2}(\partial\Phi/\partial X)(\partial\chi/\partial X_1).$$
(64)

At the surface of the crystal (r=R), no force is exerted in the *X*-direction if the crystal is in vacuo: an insignificant force is exerted in the *X*-direction if the crystal is immersed in a fluid provided $\varepsilon R \ll L$. Thus, there is no force in the *X*-direction per unit area normal to the *r*-direction and hence $\sigma_{Xr} = 0$ at r = R. Now putting

$$\gamma = \theta - \lambda \tag{65}$$

and transforming coordinates, we have

$$\sigma_{Xr} = + \sigma_{XX_1} \cos \gamma + \sigma_{XX_2} \sin \gamma$$

$$\sigma_{X\gamma} = - \sigma_{XX_1} \sin \gamma + \sigma_{XX_2} \cos \gamma$$
(66)

so that

$$\sigma_{Xr} = 2\sqrt{\nu_1\nu_2}(\partial\Phi/\partial X)((\partial\chi/\partial X_2)\cos\gamma - (\partial\chi/\partial X_1)\sin\gamma)$$

= $2\sqrt{\nu_1\nu_2}(\partial\Phi/\partial X)(1/r)(\partial\chi/\partial\gamma).$ (67)

Since $\sigma_{Xr} = 0$ at r = R, it follows that χ is independent of γ and hence constant at r = R. Thus, to within an arbitrary integration constant,

$$\chi = 0 \text{ at } r = R. \tag{68}$$

The solution of Eq. (63) subject to Eq. (68) is

$$\chi = \frac{1}{2} \left(\sqrt{v_1 v_2} / (v_1 + v_2) \right) \left(R^2 - X_1^2 - X_2^2 \right)$$

= $\frac{1}{2} \left(\sqrt{v_1 v_2} / (v_1 + v_2) \right) \left(R^2 - r^2 \right)$ (69)

which is independent of γ . Thus $\partial \chi / \partial \gamma = 0$ for $0 \le r \le R$ and so $\sigma_{Xr} = 0$ everywhere in the cylinder and not just on its surface. Provided $\varepsilon \ll 1$, convective inertial effects are insignificant compared with transient inertial effects and the two transverse components of the momentum conservation equation yield

$$\rho_c \partial^2 \xi_1 / \partial t^2 = \partial \sigma_{XX_1} / \partial X,$$

$$\rho_c \partial^2 \xi_2 / \partial t^2 = \partial \sigma_{XX_2} / \partial X.$$
(70)

Substitution of Eq. (56), Eq. (64) and Eq. (69) into Eq. (70) yields

$$\rho_{\rm c}\partial^2 \Phi/\partial t^2 = 2(\nu_1\nu_2/(\nu_1+\nu_2))\,\partial^2 \Phi/\partial X^2. \tag{71}$$

Since Φ is independent of X_1 and X_2 and hence of r and γ , it follows that the equation of motion is

$$\rho_c I \,\partial^2 \Phi / \partial t^2 = \left(1 / C_{\rm m} \right) \partial^2 \Phi / \partial X^2 \tag{72}$$

provided there is no resistance to twisting at the surface of the cylinder, i.e. provided the crystal is not surrounded by fluid. Here, the polar second moment of area I is given by

$$I = \frac{1}{2\pi R^4}$$
(73)

and the moment of compliance $C_{\rm m}$ is given by

$$1/C_m = 2\left(v_1 v_2 / (v_1 + v_2)\right) \int_0^R r^2 2\pi r \,\mathrm{d}r \tag{74}$$

so

$$C_m = \left((v_1 + v_2) / (v_1 v_2) \right) / \pi R^4 = \left(\left(c_{44} + c_{66} \right) / \left(c_{44} c_{66} - c_{14}^2 \right) \right) / \pi R^4.$$
(75)

It follows from Eqs. (66) and (69) that

$$\sigma_{X\gamma} = -2\sqrt{v_1 v_2} (\partial \Phi / \partial X) (\partial \chi / \partial r)$$

= 2 r (v_1 v_2 / (v_1 + v_2)) (\partial \Phi / \partial X) (76)

which is independent of γ .

The internal moment on a cross-section of cylinder is given by

$$M = -\int_{0}^{n} r\sigma_{X\gamma} 2\pi r \, dr$$

$$= -\left(v_1 v_2 / \left(v_1 + v_2\right)\right) \pi R^4 (\partial \Phi / \partial X) = -\left(1 / C_m\right) (\partial \Phi / \partial X).$$
(77)

It follows from Eqs. (62) and (69) that

n

$$\partial \chi / \partial X_2 = -X_2 \left(\sqrt{v_1 v_2} / (v_1 + v_2) \right) = + \frac{1}{2} \left(v_1 / \sqrt{v_1 v_2} \right) ((\partial \psi / \partial X_1) - X_2) \partial \chi / \partial X_1 = -X_1 \left(\sqrt{v_1 v_2} / (v_1 + v_2) \right) = -\frac{1}{2} \left(v_2 / \sqrt{v_1 v_2} \right) ((\partial \psi / \partial X_2) + X_1).$$
(78)

Hence,

$$\frac{\partial \psi}{\partial X_1} = \left((\nu_1 - \nu_2) / (\nu_1 + \nu_2) \right) X_2 \frac{\partial \psi}{\partial X_2} = \left((\nu_1 - \nu_2) / (\nu_1 + \nu_2) \right) X_1$$
(79)

and so, assuming without loss of generality, that there is no displacement in the X-direction of the axis $(X_1 = 0 = X_2)$ of the crystal

$$\begin{split} \psi &= \left(\left(v_1 - v_2 \right) / \left(v_1 + v_2 \right) \right) X_1 X_2 \\ &= \left(\sqrt{\left((c_{44} - c_{66})^2 + 4c_{14}^2 \right) / (c_{44} + c_{66})} \right) X_1 X_2. \end{split}$$
(80)

For quartz, $c_{14} \approx -18$ GPa, $c_{66} \approx 40$ GPa and $c_{44} \approx 58$ GPa [21] so $\psi \approx +0.41 X_1 X_2$.

Clearly, $\psi > 0$ where the product $X_1X_2 > 0$ i.e. for $\pi/2 < \gamma < \pi$ and $3\pi/2 < \gamma < 2\pi$ and $\psi < 0$ where the product $X_1X_2 < 0$ i.e. for $\pi/2 < \gamma < \pi$ and $3\pi/2 < \gamma < 2\pi$.

Because $\psi \neq 0$ except where the product $X_1X_2 = 0$ (i.e. where $X_1 = 0$ and/or $X_2 = 0$) and because $\partial \Phi / \partial X \neq 0$ at X = 0 or X = L, the distortion causes the ends of the crystal to ripple. Here we note that although Φ is a maximum with respect to X at X = 0 and X = L, its gradient with respect to X does not generally vanish there because of the non-zero moments $M|_0$ and $M|_L$ exerted by the fluid on the ends of the cylinder and, as will be seen shortly in Eq. (90), an additional piezoelectric contribution to those moments. These ripples in the ends of the crystal induce pressure fluctuations in the fluid of order $\rho \omega^2 \varepsilon^2 R^2$. It follows from Eqs. (18) and (30), however, that the shear stress components in the fluid are of order $\mu \omega \varepsilon \sqrt{\Omega} = \rho \omega^2 \varepsilon^2 R^2 / \sqrt{\varepsilon Re}$. Because $Re \ll 1$ or ~ 1 and $\epsilon \ll 1$, the effect of the ripples on the dynamics of the fluid is insignificant. Of course, for an isotropic solid where $c_{14} = 0$, $c_{44} = c_{66} = G$, where G is the shear modulus, $\psi = 0$ and there is no distortion.

In the case where there is an electric field and $E_Y \neq 0$ then Eqs. (49) yield

$$\sigma_{XX_1} = 2 \nu_1 e_{XX_1} + \tau_1 \sigma_{XX_2} = 2 \nu_2 e_{XX_2} + \tau_2$$
(81)

on transformation to $\{X, X_1, X_2\}$ coordinates, where τ_1 and τ_2 are directly proportional to E_Y , linear functions of d_{11} and d_{14} and non-linear functions of

$$\sigma_{XX_1} - \tau_1 = 2 v_1 e_{XX_1} \sigma_{XX_2} - \tau_2 = 2 v_2 e_{XX_2}$$
(82)

and so Eq. (61) becomes

$$\sigma_{XX_1} - \tau_1 = \nu_1 (\partial \boldsymbol{\Phi} / \partial X) \left(\left(\partial \psi / \partial X_1 \right) - X_2 \right) \sigma_{XX_2} - \tau_2 = \nu_2 (\partial \boldsymbol{\Phi} / \partial X) \left(\left(\partial \psi / \partial X_2 \right) + X_1 \right).$$
(83)

Equations (62) and (63) are unchanged while Eq. (64) becomes

$$\sigma_{XX_1} - \tau_1 = +2\sqrt{\nu_1\nu_2}(\partial \Phi/\partial X) (\partial \chi/\partial X_2)$$

$$\sigma_{XX2} - \tau_2 = -2\sqrt{\nu_1\nu_2}(\partial \Phi/\partial X) (\partial \chi/\partial X_1).$$
(84)

Transforming coordinates using Eq. (65) and putting

$$\tau_r = \tau_1 \cos \gamma + \tau_2 \sin \gamma$$

$$\tau_\gamma = -\tau_1 \sin \gamma + \tau_2 \cos \gamma$$
(85)

means that Eqs. (66) are unchanged while Eq. (67) becomes

$$\sigma_{Xr} - \tau_r = 2 \sqrt{\nu_1 \nu_2} (\partial \Phi / \partial X) (1/r) (\partial \chi / \partial \gamma).$$
(86)

It follows from the symmetry of the location of the electrodes that E_Y is anti-symmetric about the plane $\theta = \Phi + \pi/2 \pm \pi/2$. Thus, at r = R, the average value of E_Y is zero and so, again at r = R the average value of τ_r is zero. Since $\sigma_{Xr} = 0$ at r = R, it follows that Eqs. (68) and hence Eq. (69) still hold in an average sense. The fact that they only hold in an average sense is consistent with the different functional dependence of τ_1 and τ_2 on X_1 and X_2 from that of e_{XX_1} and e_{XX_2} : the electric field does not induce pure torsion in the crystal. Equation (70) is unchanged and so, because E_Y and hence τ_1 and τ_2 are independent of X, Eqs. (71) to (75) inclusive are unchanged though Eqs. (71) and (72) hold only in an average sense. Again, in an average sense, Eq. (76) becomes

$$\sigma_{X\gamma} - \tau_{\gamma} = 2r \big(v_1 v_2 / \big(v_1 + v_2 \big) \big) (\partial \Phi / \partial X).$$
(87)

Note that, in the same average sense, both $\sigma_{X\gamma}$ and τ_{γ} are independent of γ . Thus, the first of Eqs. (77) is unchanged while the second becomes

$$M = -\left(1/C_m\right)(\partial \Phi/\partial X) - \int_{0}^{R} \int_{0}^{2\pi} r\tau_{\gamma} r \, d\gamma dr \tag{88}$$

where the actual dependence of τ_{γ} on *r* is acknowledged. Because τ_1 and τ_2 are directly proportional to E_{γ} and hence to the applied potential *V*, it follows from Eq. (85) that τ_{γ} is directly proportional to *V*. It is convenient, therefore, to introduce an effective moment piezoelectric constant $D_{\rm m}$ given by

$$D_{\rm m} = -(1/V) \int_{0}^{R} \int_{0}^{2\pi} r \tau_{\gamma} r \, \mathrm{d}\gamma \mathrm{d}r \tag{89}$$

so that

$$M = -(1/C_{\rm m})(\partial \Phi/\partial X) + D_{\rm m}V$$
⁽⁹⁰⁾

Now, the components of the electric displacement **D** are given by

$$D_X = \varepsilon_1 E_X + 4\pi \left(d_{11}\sigma_{XX} - d_{11}\sigma_{YY} + d_{14}\sigma_{YZ} \right)$$
(91)

$$D_Y = \varepsilon_1 E_Y + 4\pi \left(-d_{14}\sigma_{XZ} - 2d_{11}\sigma_{XY} \right)$$
(92)

$$D_Z = \varepsilon_3 E_Z \tag{93}$$

The surface charge per unit area is given by the outward normal component D_n of D at the surface of the crystal: thus $D_n = -D_X$ at X = 0, $D_n = +D_X$ at X = L and $D_n = +D_r$ at r = R. It follows from Eqs. (36), (43), (46) and (56) that

$$D_X|_0 = 4\pi d_{11}\sigma_{XX}|_0 = 4\pi d_{11}c_{11}\psi(\partial^2 \Phi/\partial X^2)|_0$$
(94)

$$D_X|_L = 4\pi d_{11}\sigma_{XX}|_L = 4\pi d_{11}c_{11}\psi(\partial^2 \Phi/\partial X^2)|_L$$
(95)

where ψ is given by Eq. (80) and

$$D_r|_R = D_Y|_R \cos\theta + D_Z|_R \sin\theta = 4\pi (-d_{14}\sigma_{XZ}|_R - 2d_{11}\sigma_{XY}|_R) \cos\theta + (\varepsilon_1 E_Y|_R + \varepsilon_3 E_Z|_R \sin\theta).$$
(96)

But

$$\sigma_{XY} = \sigma_{Xr} \cos \theta - \sigma_{X\theta} \sin \theta$$

$$\sigma_{XZ} = \sigma_{Xr} \sin \theta + \sigma_{X\theta} \cos \theta$$
(97)

so

$$D_r|_R = 4\pi \left(-d_{14}\cos\theta + 2d_{11}\sin\theta \right) \sigma_{X\theta}|_R \cos\theta + \left(\epsilon_1 E_Y|_R \cos\theta + \epsilon_3 E_Z|_R \sin\theta \right)$$
(98)

since $\sigma_{Xr|R} = 0$.

Substitution from Eq. (87) yields in an average sense

$$D_{r}|_{R} = 4\pi \left(-d_{14}\cos\theta + 2d_{11}\sin\theta\right) \left[\left(2R\left(\nu_{1}\nu_{2}/\left(\nu_{1}+\nu_{2}\right)\right)\left(\partial\Phi/\partial X\right)\right) + \tau_{\gamma}|_{R,\theta-\lambda} \right] \cos\theta + \left(\varepsilon_{1}E_{\gamma}|_{R}\cos\theta + \varepsilon_{3}E_{Z}|_{R}\sin\theta\right)$$

$$(99)$$

where $\tau_{\gamma}|_{R,\theta-\lambda}$ implies that τ_{γ} is to be evaluated at r = R and $\gamma = \theta - \lambda$.

The total surface charge Q on the crystal is given by

$$Q = \int_{0}^{R} \int_{0}^{2\pi} \left(-D_X|_0 + D_X|_L \right) r d\theta dr + R \int_{0}^{L} \int_{0}^{2\pi} D_r|_R d\theta dX.$$
(100)

It follows from Eqs. (94) and (95) that

$$\int_{0}^{R} \int_{0}^{2\pi} \left(-D_{X} |_{0} + D_{X} |_{L} \right) r d\theta dr = 4\pi d_{11} c_{11} \left[\left(\partial^{2} \boldsymbol{\Phi} / \partial X^{2} \right) |_{L} - \left(\partial^{2} \boldsymbol{\Phi} / \partial X^{2} \right) |_{0} \right] \int_{0}^{R} \int_{0}^{2\pi} \psi r d\theta dr.$$
(101)

Integration with respect to θ over the range 0 to 2π is the same as integration with respect to $\gamma = \theta - \lambda$ over the range 0 to 2π . Hence it follows from Eq. (80) that

$$\int_{0}^{R} \int_{0}^{2\pi} \psi r d\theta dr = \left[\frac{(v_1 - v_2)}{(v_1 + v_2)} \right] \int_{0}^{R} r^3 dr \int_{0}^{2\pi} \cos \gamma \, \sin \gamma \, d\gamma$$
(102)

since $X_1 = r\cos\gamma$ and $X_2 = r\sin\gamma$ and so

$$\int_{0}^{R} \int_{0}^{2\pi} (-D_{X}|_{0} + D_{X}|_{L}) r d\theta dr = 0.$$
(103)

Thus, there is no net contribution to the total charge, Q, from the ends (z=0 and z=L) of the cylinder. This is true despite the fact that Eq. (87) holds only in an average sense: symmetry means that, although there is rippling of the ends of the crystal, there is no net strain in either end, which in turn means that there is no net stress on either end and hence no net electric displacement at either end. It follows, therefore, that Eq. (100) yields, in an average sense

$$Q = 8\pi R^{2} \left[\frac{v_{1}v_{2}}{(v_{1}+v_{2})} \right] \int_{0}^{L} (\partial \Phi / \partial X) dX \int_{0}^{2\pi} \left(-d_{14}\cos\theta + 2d_{11}\sin\theta \right) \cos\theta d\theta + 4\pi R \int_{0}^{L} dX \int_{0}^{2\pi} \left(-d_{14}\cos\theta + 2d_{11}\sin\theta \right) \cos\theta \tau_{\gamma}|_{R,\theta-\lambda} d\theta + R \int_{0}^{L} dX \int_{0}^{2\pi} \left(\varepsilon_{1}E_{Y}|_{R}\cos\theta + \varepsilon_{3}E_{Z}|_{R}\sin\theta \right) d\theta.$$
(104)

Thus, again in an average sense

$$Q = 8\pi R^2 \left(\frac{v_1 v_2}{(v_1 + v_2)}\right) \left(\boldsymbol{\Phi}|_L - \boldsymbol{\Phi}|_0\right) \int_0^{2\pi} \left(-d_{14}\cos\theta + 2d_{11}\sin\theta\right)\cos\theta d\theta + 4\pi RL \int_0^{2\pi} \left(-d_{14}\cos\gamma + 2d_{11}\sin\gamma\right)\cos\gamma \tau_{\gamma}|_R d\gamma + RL \int_0^{2\pi} \left(\varepsilon_1 E_Y|_R\cos\theta + \varepsilon_3 E_Z|_R\sin\theta\right) d\theta$$
(105)

It follows from Eqs. (57), (58) and (81) that $(\boldsymbol{\Phi}|_L - \boldsymbol{\Phi}|_0)$ is directly proportional to *V*, provided $\epsilon \ll 1$. Because τ_{γ} is also directly proportional to *V*, it follows that τ_{γ} is directly proportional to $(\boldsymbol{\Phi}|_L - \boldsymbol{\Phi}|_0)$. It is convenient, therefore, to introduce another effective moment piezoelectric constant $E_{\rm m}$ given by

$$E_{\rm m} = 8\pi R^2 \left(\frac{v_1 v_2}{(v_1 + v_2)} \right) \int_0^{2\pi} (-d_{14} \cos \theta + 2d_{11} \sin \theta) \cos \theta d\theta + \left(\frac{4\pi RL}{(\boldsymbol{\Phi}|_L - \boldsymbol{\Phi}|_0)} \right) \int_0^{2\pi} (-d_{14} \cos \gamma + 2d_{11} \sin \gamma) \cos \gamma \tau_{\gamma}|_R d\gamma.$$
(106)

The capacitance C of the crystal is given by

$$C = \left(\frac{RL}{V}\right) \begin{bmatrix} \oint_{\phi}^{\phi+\pi/2} (\epsilon_1 E_Y|_R \cos\theta + \epsilon_3 E_Z|_R \sin\theta) \, \mathrm{d}\theta - \int_{\phi+\pi/2}^{\phi+\pi} (\epsilon_1 E_Y|_R \cos\theta + \epsilon_3 E_Z|_R \sin\theta) \, \mathrm{d}\theta \\ & \phi+3\pi/2 \\ + \int_{\phi+\pi}^{\phi+3\pi/2} (\epsilon_1 E_Y|_R \cos\theta + \epsilon_3 E_Z|_R \sin\theta) \, \mathrm{d}\theta - \int_{\phi+3\pi/2}^{2\pi} (\epsilon_1 E_Y|_R \cos\theta + \epsilon_3 E_Z|_R \sin\theta) \, \mathrm{d}\theta \end{bmatrix}$$
(107)

or since $\epsilon \ll 1$

$$C = \left(\frac{RL}{V}\right) \begin{bmatrix} \int_{0}^{\pi/2} (\varepsilon_1 E_Y|_R \cos\theta + \varepsilon_3 E_Z|_R \sin\theta) d\theta - \int_{\pi/2}^{\pi} (\varepsilon_1 E_Y|_R \cos\theta + \varepsilon_3 E_Z|_R \sin\theta) d\theta \\ \int_{0}^{3\pi/2} (\varepsilon_1 E_Y|_R \cos\theta + \varepsilon_3 E_Z|_R \sin\theta) d\theta - \int_{3\pi/2}^{2\pi} (\varepsilon_1 E_Y|_R \cos\theta + \varepsilon_3 E_Z|_R \sin\theta) d\theta \end{bmatrix}$$
(108)

where $E_Y = -\partial V/\partial Y$, $E_Z = -\partial V/\partial Z$ and V is given by Eq. (48). We can write Eq. (105) as

$$Q = CV + E_{\rm m}(\boldsymbol{\Phi}|_{L} - \boldsymbol{\Phi}|_{0}).$$
⁽¹⁰⁹⁾

The moment of compliance, $C_{\rm m}$ and the effective piezoelectric constants $D_{\rm m}$ and $E_{\rm m}$ are defined by Eqs. (75), (89) and (106), respectively. They can, therefore, be determined, in principle, from the fundamental elastic and piezoelectric constants of the crystal as well as its dimensions (*R* and *L*). It is more convenient, however, to determine $C_{\rm m}$, $D_{\rm m}$ and $E_{\rm m}$ from the resonant and anti-resonant frequencies of the crystal in vacuo instead. The capacitance *C* is defined by Eq. (108) and can, therefore, be determined from the fundamental crystal constants (now also including ε_1 and ε_3) and the size of the crystal. It is more convenient, however, to determine *C* from the overall electrical properties of the crystal instead.

4 System Mechanics

For torsional motion of a cylinder in a fluid, Eq. (72) must be modified using Eq. (21) to yield

$$\left(\rho_{c}I+k\right)\partial^{2}\Phi/\partial t^{2}+\omega k\,\partial\Phi/\partial t=\left(1/C_{m}\right)\partial^{2}\Phi/\partial z^{2}=-\partial M/\partial z \qquad (110)$$

where M is given in Eq. (90).

Substitution of Eq. (1) into Eq. (110) yields

$$\frac{\mathrm{d}^2\varepsilon}{\mathrm{d}z^2} + a\omega^2\,\varepsilon - i\omega b\,\varepsilon = 0 \tag{111}$$

where

$$a = \rho_{\rm c} I C_{\rm m} + k C_{\rm m}, b = \omega k C_{\rm m}$$
(112)

When the transient that occurs on start-up of the crystal has decayed, the solution of Eq. (111) is

$$\epsilon = \alpha \cosh(\Gamma z) + \beta \sinh(\Gamma z) \tag{113}$$

where

$$\Gamma = \Gamma_{\rm r} + i\Gamma_{\rm i} = \sqrt{\left(-\omega^2 a + i\,\omega\,b\right)} \tag{114}$$

so that

$$\Gamma_{\rm r} = \sqrt{(1/2\omega^2 a (1 + (b^2/\omega^2 a^2))^{1/2} - 1)}$$
(115)

$$\Gamma_{\rm i} = \sqrt{(1/2\omega^2 a (1 + (b^2/\omega^2 a^2))^{1/2} + 1)},\tag{116}$$

For practical viscometers, $(k/\rho_c I) \ll 1$ so $(b/\omega a) = (k/(\rho_c I + k)) \ll 1$ and so

$$\Gamma_{\rm r} = \frac{b}{2\sqrt{a}}, \ \Gamma_{\rm i} = \omega\sqrt{(a(1+(b^2/4\omega^2 a^2))^{1/2})} = \omega\sqrt{a}.$$
(117)

Now, at z = 0, Eqs. (1) and (113) yield

$$i\omega\alpha \exp(i\omega t) = \partial \Phi / \partial t|_0$$
 (118)

and Eq. (114) yields

$$\beta \exp(i\omega t) = -(C_{\rm m}/\Gamma) (M|_0 - D_{\rm m}V).$$
(119)

Hence

$$\partial \Phi / \partial t = \partial \Phi / \partial t |_0 \cosh(\Gamma z) - \frac{(M|_0 - D_m V)}{(\Gamma / i\omega C_m)} \sinh(\Gamma z)$$
(120)

and

$$(M - D_{\rm m}V) = (M|_0 - D_{\rm m}V) \cosh(\Gamma z) - (\Gamma/i\omega C_{\rm m}) (\partial \Phi/\partial t|_0) \sinh(\Gamma z).$$
(121)

The current, A, is given by A = dQ/dt with Q given by Equation (109) and so

$$A = i\omega CV + E_{\rm m} \left\{ \left| \frac{\partial \Phi}{\partial t} \right|_L - \left| \frac{\partial \Phi}{\partial t} \right|_0 \right\}.$$
(122)

Putting

$$Z_{1} = \Gamma/i\omega C_{\rm m}, Z_{2} = +M|_{L}/(\partial \Phi/\partial t)|_{L} = -M|_{0}/(\partial \Phi/\partial t)|_{0} = \frac{1}{4}(1+i)k\omega R$$
(123)

using Eqs. (32) and (33). Then Eqs. (120) and (121) become

$$\left(\frac{\partial \Phi}{\partial t}\right)|_{L} = \left(\frac{\partial \Phi}{\partial t}\right)|_{0} \cosh(\Gamma L) - \left(\left(\frac{M}{0} - \left(\frac{D_{m}V}{V}\right)\right)/Z_{1}\right) \sinh(\Gamma L) \quad (124)$$

and

$$\left(M|_{L}-\left(D_{m}V\right)\right) = \left(M|_{0}-\left(D_{m}V\right)\right) \cosh(\Gamma L) - Z_{1}(\partial \Phi/\partial t)|_{0} \sinh(\Gamma L).$$
(125)

Thus, eliminating $M|_L$ and $M|_0$

$$\left(\frac{\partial \Phi}{\partial t}\right)\Big|_{L} = \left(\frac{\partial \Phi}{\partial t}\right)\Big|_{0} \cosh\left(\Gamma L\right) + \left(\left(\frac{Z_{2}}{Z_{1}}\right)\left(\frac{\partial \Phi}{\partial t}\right)\Big|_{0} + \left(\frac{D_{m}V}{Z_{1}}\right)\right) \sinh\left(\Gamma L\right)$$
(126)

$$\left(\frac{Z_2}{Z_1}\left(\frac{\partial \boldsymbol{\Phi}}{\partial t}\right)\Big|_L - \left(D_m V / Z_1\right)\right) = -\left(\frac{Z_2}{Z_1}\left(\frac{\partial \boldsymbol{\Phi}}{\partial t}\right)\Big|_0 + \left(\frac{D_m V}{Z_1}\right)\right)\cosh\left(\Gamma L\right) - \left(\frac{\partial \boldsymbol{\Phi}}{\partial t}\right)\Big|_0\sinh\left(\Gamma L\right)$$
(127)

and so, eliminating $(\partial \Phi / \partial t)|_L$

$$\left(\frac{\partial \boldsymbol{\Phi}}{\partial t}\right)|_{0} = D_{\mathrm{m}}V\left[\frac{\left(-Z_{2}/Z_{1}\right) + \operatorname{cosech}(\Gamma L) - \operatorname{coth}(\Gamma L)}{Z_{1} + \left(Z_{2}^{2}/Z_{1}\right) + 2Z_{2}\operatorname{coth}(\Gamma L)}\right]$$
(128)

while

$$\left(\frac{\partial \boldsymbol{\Phi}}{\partial t}\right)\Big|_{L} = -\left(\frac{\partial \boldsymbol{\Phi}}{\partial t}\right)\Big|_{0} = D_{\mathrm{m}}V\left[\frac{\left(Z_{2}/Z_{1}\right) + \tanh\left(\frac{1}{2}\Gamma L\right)}{Z_{1} + \left(Z_{2}^{2}/Z_{1}\right) + 2Z_{2}\operatorname{coth}\left(\Gamma L\right)}\right].$$
 (129)

Thus, the general equation for the current, Eq. (122), becomes

$$A = i\omega CV + 2D_{\rm m}E_{\rm m}V \frac{(Z_2/Z_1) + \tanh(1/2\Gamma L)}{(Z_1 + (Z_2^2/Z_1) + 2Z_2\coth(\Gamma L))}.$$
 (130)

4.1 Crystal in Vacuo

For a crystal in *vacuo*, k=0 and $a = \rho_c I C_m$, b=0.

Thus,

$$\Gamma_{\rm r} = 0, \ \Gamma_{\rm i} = \omega \sqrt{\rho_{\rm c} I \, C_{\rm m}} \tag{131}$$

and

$$Z_1 = \sqrt{\left(\rho_{\rm c} I/C_{\rm m}\right)}, Z_2 = 0.$$
 (132)

Hence Eq. (130) becomes

$$A = i\omega CV + 2D_{\rm m}E_{\rm m}V \frac{\tanh(1/2\,i\omega L\,\sqrt{\rho_{\rm c}I\,C_{\rm m}})}{\sqrt{\rho_{\rm c}I\,C_{\rm m}}}$$
(133)

or

$$A = i V \frac{\omega C + 2 D_{\rm m} E_{\rm m} \tan(1/2\omega L \sqrt{\rho_{\rm c} I C_{\rm m}}))}{\sqrt{\rho_{\rm c} I C_{\rm m}}}.$$
 (134)

Thus $|A| \rightarrow \infty$ and resonance occurs when $\omega = \omega_{0R}$ where ω_{0R} is given by

$$\omega_{0R} = \frac{\pi}{L\sqrt{\rho_c I C_m}}$$
(135)

which can, of course, be used to determine $C_{\rm m}$. Also $|A| \to 0$ and anti-resonance occurs when $\omega = \omega_{0\rm A}$ where $\omega_{0\rm A}$ is given by the solution of

$$\omega_{0A}C + 2D_{m}E_{m}\frac{\tan(1/2\,i\omega_{0A}L\,\sqrt{\rho_{c}I\,C_{m}})}{\sqrt{\rho_{c}IC_{m}}} = 0.$$
(136)

If we let

$$\omega_{0A} = \omega_{0R} + \Delta \omega_0 \tag{137}$$

then

$$\tan(1/2\omega_{0A}L\sqrt{\rho_{c}IC_{m}}) = \tan(1/2\omega_{0R}L\sqrt{\rho_{c}IC_{m}})(1 + (\Delta\omega_{0}/\omega_{0R})).$$
(138)

The use of trigonometric relationships leads to

$$\tan(1/2\omega_{0A}L\sqrt{\rho_c I C_m}) = -1/\tan\left(\frac{\pi\Delta\omega_0}{2\omega_{0R}}\right).$$
(139)

In practice, $\Delta \omega_0 \ll \omega_{0R}$ so, since $\tan(x) = x$ for $x \ll 1$

$$\tan(1/2\omega_{0A}L\sqrt{\rho_{c}IC_{m}}) = -(2/\pi)(\omega_{0R}/\Delta\omega_{0})$$
(140)

thus, Eq. (136) yields

$$\omega_{0R}(1 + (\Delta\omega_0/\omega_{0R}))C = 4D_m E_m \omega_{0R} / (\sqrt{(\rho_c I/C_m)\pi \Delta\omega_0})$$
(141)

whence, because $\Delta \omega_0 \ll \omega_{0R}$

$$D_{\rm m}E_{\rm m} = \frac{1}{4\pi}\sqrt{(\rho_{\rm c}I/C_{\rm m})C\Delta\omega_0} = \frac{1}{4\pi^2}(C/C_{\rm m}L)(\Delta\omega_0/\omega_{0\rm R})$$
(142)

which can be used to determine the product $D_{\rm m}E_{\rm m}$. We note that, although $D_{\rm m}$ and $E_{\rm m}$ are not determined separately, it is only their product that is of relevance. We also note that it follows from Eq. (142) that $\Delta\omega_0 > 0$ so that $\omega_{0\rm A} > \omega_{0\rm R}$.

4.2 Cystal in a Fluid

If there is fluid around the crystal, substitution of Eq. (142) into Eq. (130) yields

$$A = V \left\{ i\omega C + \frac{1}{2\pi^2} \left(C / C_m L \right) (\Delta \omega_0 / \omega_{0R}) \left[\frac{(Z_2 / Z_1) + \tanh(\frac{1}{2\Gamma L})}{(Z_1 + (Z_2^2 / Z_1) + 2Z_2 \coth(\Gamma L))} \right] \right\}.$$
(143)

Now we can assume that near resonance in the fluid, $\omega \sim \omega_{0R}$ so that $\Gamma_{\rm r} \ll \Gamma_{\rm i} \sim \pi/L$. Expanding $\tanh(1/2 \Gamma L)$ yields

$$\tanh(1/2\Gamma L) = \tanh(1/2(\Gamma_{\rm r} + i\Gamma_{\rm i})L) = \frac{\left[\tanh(1/2\Gamma_{\rm r}L) + i\tan(1/2\Gamma_{\rm i}L)\right]}{\left[1 + i\tanh(1/2\Gamma_{\rm r}L)\tan(1/2\Gamma_{\rm i}L)\right]}.$$
(144)

Since $\Gamma_{\rm r} \ll \Gamma_{\rm i} \sim \pi/L$ it follows that

$$\tanh(1/2\Gamma L) = \frac{i}{(\cot(1/2\Gamma_{i}L) + i \tanh(1/2\Gamma_{r}L))} = \frac{1}{(\tanh(1/2\Gamma_{r}L) - i \cot(1/2\Gamma_{i}L))}.$$
(145)

But Eqs. (112), (117) and (135) yield

$$\Gamma_{\rm i}L = \omega L \sqrt{\left(\rho_{\rm c}I C_{\rm m} + k C_{\rm m}\right)} = \pi \left(\omega / \omega_{\rm 0R}\right) \sqrt{\left(1 + \left(k / \rho_{\rm c}I\right)\right)}$$
(146)

so, if

$$\omega = \omega_{0R} + \Delta\omega \tag{147}$$

it follows that

$$\tan(1/2\Gamma_{\rm i}L) = -1/\tan\left[\frac{\pi}{2}((\Delta\omega/\omega_{0R}) + 1/2(k/\rho_{\rm c}I))\right].$$
 (148)

Thus Eq. (145) yields

$$\tanh(\Gamma L/2) = \frac{1}{\tanh(\Gamma_{\rm r} L/2) + i \tan((\pi/2)((\Delta \omega/\omega_{0\rm R}) + (k/\rho_{\rm c} I)/2))}$$
(149)

and, since $\Gamma_{\rm r} \ll \Gamma_{\rm i} \sim \pi / L$, $|\Delta \omega| / \omega_{\rm 0R} \ll 1$ and $(k / \rho_{\rm c} I) \ll 1$ expanding $\tanh(\Gamma L)$

$$\tanh(\Gamma L) = \tanh((\Gamma_{\rm r} + i\Gamma_{\rm i})L) = \frac{\tanh(\Gamma_{\rm r}L) + i\tan(\Gamma_{\rm i}L)}{1 + i\tanh(\Gamma_{\rm r}L)\tan(\Gamma_{\rm i}L)}$$

$$= \frac{\tanh(\Gamma_{\rm r}L) + i\tan(\pi((\Delta\omega/\omega_{0\rm R}) + \frac{1}{2}(k/\rho_{\rm c}I)))}{(150)}$$

$$\frac{1}{1 + i (\tanh(\Gamma_{\rm r}L) \tan(\pi(1 + (\Delta \omega/\omega_{0\rm R})) \sqrt{(1 + (k/\rho_{\rm c}I))))}}$$

since $\tan(\pi + x) = \tan(x)$.

Now, because $\Gamma_{\rm r} \ll \Gamma_{\rm i} \sim \pi/L$, $|\Delta \omega|/\omega_{0R} \ll 1$ and $(k/\rho_c I) \ll 1$

$$\operatorname{coth}(\Gamma L) = \frac{1 - i\Gamma_{r} L \pi((\Delta \omega / \omega_{0R}) + \frac{1}{2} (k / \rho_{c} I))}{\Gamma_{r} L + i\pi((\Delta \omega / \omega_{0R}) + \frac{1}{2} (k / \rho_{c} I))}$$
(151)

and so, to leading order

$$\operatorname{coth}(\Gamma L) = \frac{\Gamma_{\rm r} L - i\pi((\Delta \omega/\omega_{0\rm R}) + \frac{1}{2}(k/\rho_{\rm c} I))}{(\Gamma_{\rm r} L)^2 + (\pi((\Delta \omega/\omega_{0\rm R}) + \frac{1}{2}(k/\rho_{\rm c} I)))^2}.$$
 (152)

Thus Eq. (143) becomes

$$A = V \left[i\omega C + (\pi^2/2) \left(C/C_{\rm m}L \right) \left(\Delta \omega_0 / \omega_{0\rm R} \right) \Xi \right]$$
(153)

where

$$\Xi = \frac{\left(Z_2/Z_1\right)\left(\Gamma_r L + i\pi((\Delta\omega/\omega_{0R}) + \frac{1}{2}(k/\rho_c I))\right) + 2}{\left(Z_1 + \left(Z_2^2/Z_1\right)\right)\left((\Gamma_r L + i\pi((\Delta\omega/\omega_{0R}) + \frac{1}{2}(k/\rho_c I)))\right) + 2Z_2}.$$
 (154)

It follows from Eq. (123) that

$$Z_2/Z_1 = \frac{1}{4}(1+i)k\omega R/((\Gamma_r + i\Gamma_i)/i\omega C_m)$$
(155)

and from Eq. (146) that $\Gamma_{\rm r} \ll \Gamma_{\rm i} \sim \omega/(\omega_{0R}L)$ so $Z_2/Z_1 \sim k\omega^2 RC_{\rm m}/(\omega/(\omega_{0R}/L))$. But $\omega \sim \omega_{0R}$ so, using Eq. (135), it follows that $Z_2/Z_1 \sim kR/(\rho_{\rm c}IL)$. Hence, because $k/(\rho_{\rm c}I) \ll 1$ and $R/L \ll 1$ or ~ 1 in practice, it follows that $Z_2/Z_1 \ll 1$. Thus, to leading order

$$\Xi = 1/[Z_2 + 1/2Z_1(\Gamma_r L + i\pi ((\Delta \omega/\omega_{0R}) + 1/2(k/\rho_c I)))]$$
(156)

and so

$$A = V \frac{i\omega C + ((\pi^2/2) (C / C_m L) (\Delta \omega_0 / \omega_{0R})}{(Z_2 + 1/2 Z_1 (\Gamma_r L + i\pi ((\Delta \omega / \omega_{0R}) + 1/2 (k / \rho_c I)))))}.$$
 (157)

Put

$$Z_2 = Z_{2r} + i Z_{2i} \tag{158}$$

where from Eq. (123)

$$Z_{2r} = Z_{2i} = \frac{1}{4k\omega R}.$$
 (159)

Because $Z_1 = \Gamma_i / (\omega C_m)$ since $\Gamma_r \ll \Gamma_i \sim \pi/L$, it follows that Z_1 is real to leading order and hence

$$\Xi = 1 / [(Z_{2r} + 1/2 Z_1 \Gamma_r L) + i(Z_{2i} + 1/2 Z_1 \pi ((\Delta \omega / \omega_{0R}) + 1/2 (k / \rho_c I)))].$$
(160)

For an electrical circuit comprising a capacitance, C_1 , in parallel with a series combination of a resistance R_2 , an inductance, L_2 and a capacitance C_2 , an applied potential $V = V_0 \exp(i\omega t)$ gives the total current A through the whole electrical circuit as

$$A = V [i\omega C_1 + (1/(R_2 + i(\omega L_2 - (1/\omega C_2))))].$$
(161)

Comparison of Eqs. (153) and (160) with Eq. (161) reveals the following equivalences

$$C_1 \equiv C \tag{162}$$

$$R_2 \equiv (Z_{2r} + \frac{1}{2}Z_1\Gamma_r L)/(\frac{1}{2\pi^2}(C/C_m L)(\Delta\omega_0/\omega_{0R}))$$
(163)

$$\omega L_2 - (1/\omega C_2) \equiv \frac{[Z_{2i} + \frac{1}{2}Z_1 \pi ((\Delta \omega_0 / \omega_{0R}) + \frac{1}{2}(k/\rho_c I))]}{[\frac{1}{2}\pi^2 (C/C_m L)(\Delta \omega_0 / \omega_{0R})]}.$$
 (164)

If we let

$$\Sigma = \omega L_2 - (1/\omega C_2) \tag{165}$$

,

then the impedance, Z, is

$$Z = 1 / [i\omega C_1 + (1 / (R_2 + i\Sigma))] = 1 / [i\omega C_1 + ((R_2 - i\Sigma) / (R_2^2 + \Sigma^2))]$$
(166)

and finally

$$Z = [R_2 - i(\omega C_1 R_2^2 + \omega C_1 \Sigma^2 - \Sigma)] / [(1 - \omega C_1 \Sigma)^2 + (\omega C_1 R_2)^2].$$
(167)

If the crystal in the fluid is balanced in a bridge circuit by a variable resistance R^* in parallel with a variable capacitance C^* then an applied potential V gives a current V/R^* in the resistance and a current V i ω C* in the capacitance. Thus, the impedance Z^* is given by

$$Z^* = 1/((1/R^*) + i\omega C^*) = (R^* - i\omega C^* R^* 2) / (1 + (\omega C^* R^*)^2).$$
(168)

If the bridge is balanced, then $Z^* = Z$ and so Eqs. (167) and (168) yield

$$R^*/(1 + (\omega C^* R^*)^2) = R_2/((1 - \omega C_1 \Sigma)^2 + (\omega C_1 R_2)^2)$$
(169)

and

$$\omega C^* R^{*2} / (1 + (\omega C^* R^*)^2) = \left[(\omega C_1 R_2^2) + (\omega C_1 \Sigma^2) - \Sigma \right] / \left[(1 - \omega C_1 \Sigma)^2 + (\omega C_1 R_2)^2 \right]$$
(170)

whence

$$\omega C^* R^* = ((\omega C_1 R_2^2) + (\omega C_1 \Sigma^2) - \Sigma) / R_2.$$
(171)

Thus,

$$R^* = R_2 [1 + (((\omega C_1 R_2^2) + (\omega C_1 \Sigma^2) - \Sigma)^2 / R_2^2)] / [(1 - \omega C_1 \Sigma)^2 + (\omega C_1 R_2)^2]$$
(172)

or

$$R^* = R_2(1 + (\Sigma^2/R_2^2))$$
(173)

and

$$C^* = \left[\left(\omega C_1 R_2^2 \right) + \left(\omega C_1 \Sigma^2 \right) - \Sigma \right] / \left[\omega R_2^2 (1 + \left(\Sigma^2 / R_2^2 \right)) \right]$$
(174)

or

$$C^* = C_1 - \left[\Sigma / \left(\omega R_2^2 \left(1 + \left(\Sigma^2 / R_2^2 \right) \right) \right) \right].$$
(175)

Note that the minimum value of the resistance, R^* , with respect to frequency ω occurs when

$$\Sigma = 0 \tag{176}$$

and then

$$R^* = R_2, \ C^* = C_1. \tag{177}$$

It follows from Eq. (165) that Σ vanishes at a frequency $\omega = \tilde{\omega}$ given by

$$\tilde{\omega} = 1 / \sqrt{L_2 C_2}. \tag{178}$$

If $\omega \ll \tilde{\omega}$ or $\omega \gg \tilde{\omega}$ then $|\Sigma| \gg R_2$ and it follows from Eqs. (173) and (175) that $R^* \to \infty$ and $C^* = C_1$.

When the crystal is immersed in a fluid, resonance is, in practice, defined to occur not when |A| is a maximum but when the balancing resistance R^* in the bridge circuit is a minimum. Using Eqs. (164), (165) and (175), it follows that resonance occurs when $\omega = \omega_{1R} = \omega_{0R} + \Delta \omega_1$ where $\Delta \omega_1$ is given by

$$\Delta \omega_1 = -\omega_{0R} [(2/\pi) (Z_{2i}/Z_1) + (1/2k/(\rho_c I))]$$
(179)

or

$$\Delta \omega_1 = -\omega_{0R} (1 + (R/L))k/(2\rho_c I)$$
(180)

which shows that $\Delta \omega_1 < 0$, so that $\omega_{1R} < \omega_{0R}$. Also, since $k/(\rho_c I) \ll 1$ and $(R/L) \ll 1$ or ~ 1 in practice, it follows that $|\Delta \omega_1| / \omega_{0R} \ll 1$, as assumed originally, thus proving consistency. Substituting for *k* using Eq. (22) and for *I* using Eq. (73) yields

$$\Delta\omega_{1} = -\left[\pi R^{3} / (\rho_{c}I)\right] \sqrt{1/2 \rho \,\mu \omega_{0R}} (1 + (R/L))$$

= $-\left[2 / (\rho_{c}R)\right] \sqrt{1/2 \rho \,\mu \omega_{0R}} (1 + (R/L))$ (181)

The term (1 + (R/L)) in Eq. (181) is a result of the two contributions to viscous drag on the crystal: the first from its curved surface at r = R and the second, a factor (R/L) of the size of the first, from its ends at z = 0 and z = L.

5 Working Equations for a Viscometer

In order to use the torsional quartz crystal as a viscometer it is necessary to explicitly relate the viscosity of the fluid surrounding the crystal to parameters of the resonance that can be measured with a small uncertainty and to the measurable physical characteristics of the crystal. When the idea of the viscometer was first proposed by electrical engineers, it was possible to attain the greatest relative precision in the measurement of the width of the resonant peak. However, we should also recognize that with modern instrumentation it is possible to achieve exceedingly high precision in the measurement of the resonant frequency itself so that we also consider first that quantity in devising a working equation for the viscometer. Subsequently we return to the bandwidth measurement to find a second working equation.

5.1 Working Equation for the Resonant Frequency with Only Viscous Losses

It follows from Eq. (181) and using Eq. (73) that the viscosity of the fluid, assuming that there are no losses in the system except viscous losses is given by

$$\mu = \frac{\rho_c^2 R^2 (\omega_{0R} - \omega_{1R})^2}{2[\rho \omega_{0R} (1 + (R/L))^2]}.$$
(182)

5.2 Working Equation for a Real Crystal

In a real crystal, there is bound to be non-viscous damping resulting from internal losses. In addition, there will inevitably be losses such as those arising from the crystal support.

As a result, Eq. (110) must be replaced by

$$\left(\rho_c I + k + K\right) \frac{\partial^2 \Phi}{\partial t^2} + \omega(k + K) \frac{\partial \Phi}{\partial t} = \left(1/C_{\rm m}\right) \frac{\partial^2 \Phi}{\partial z^2} = -\frac{\partial M}{\partial z} \tag{183}$$

where all non-viscous losses are accounted for in the damping coefficient, K, and all viscous losses are accounted for in k. The presence of non-viscous damping means that ω_{0R} given by Eq. (135) is a theoretical quantity that cannot be measured directly and also cannot be determined from Eq. (135) since C_m is unknown. Thus ω_{0R} is not the resonant frequency of the real crystal in vacuo: instead, resonance in vacuo must be defined to occur when the balancing resistance R^* in the bridge circuit is a minimum, just as it is for a crystal in a fluid. Henceforth, it is assumed that the crystal is a real one so that $K \neq 0$ and, for clarity, all frequencies for the real system are denoted with a superscript *.

For the real crystal in vacuo then k=0 and it follows by analogy with Eq. (180) that

$$\omega_{0R}^{*} = \omega_{0R} \left\{ 1 - \left[\frac{1}{2} (1 + (R/L)) K / (\rho_{c} I) \right] \right\}$$
(184)

where ω_{0R} is given by Eq. (135) and it follows that

$$K = \frac{2(\omega_{0R} - \omega_{0R}^*)\rho_c I}{\left[\omega_{0R}(1 + (R/L))\right]}.$$
(185)

If the crystal is in a fluid, then $k \neq 0$ and it follows by analogy with Eq. (180) that

$$\omega_{1R}^{*} = \omega_{0R} \left\{ 1 - \left[\frac{(1 + (R/L))K}{2(\rho_{c}I)} \right] - \left[\frac{(1 + (R/L))k}{2(\rho_{c}I)} \right] \right\}$$
(186)

where ω_{0R} is again given by Eq. (135) and it follows that

$$k + K = \frac{2(\omega_{0R} - \omega_{1R}^*)\rho_c I}{\omega_{0R}(1 + (R/L))}.$$
(187)

Because any well-designed viscometer would ensure that $K \ll \text{ or } \sim k$, it follows that $K/(\rho_c I) \ll 1$ and so it follows from Eqs. (184) and (186) that ω_{0R}^* is slightly lower than ω_{0R} and that in turn, ω_{1R}^* is slightly lower than ω_{0R}^* . It follows from Eqs. (185) and (187) that

$$k = \frac{2(\omega_{0R}^* - \omega_{1R}^*) \rho_c I}{\omega_{0R}(1 + (R/L))}$$
(188)

from which it follows using Eqs. (22) and (73) that

$$\mu = \frac{\rho_{\rm c}^2 R^2 \omega_{1\rm R}^* (\omega_{0\rm R}^* - \omega_{1\rm R}^*)^2}{2\rho \omega_{0\rm R}^2 (1 + (R/L))^2}.$$
(189)

This cannot be used as a working equation for the viscometer as it stands because it still contains ω_{0R} which cannot be measured directly.

No electrical power is dissipated in the capacitance C^* in the bridge circuit provided it is a pure capacitance: the power, P, is dissipated only in the resistance R^* and is given in terms of the root-mean-square voltage $V_{\rm rms}$ and root-mean-square current $A_{\rm rms}$ by

$$P = V_{\rm rms}^2 / R^* = A_{\rm rms}^2 R^*$$
(190)

and it follows from Eq. (45) that

$$P = \frac{1}{2}V_0^2/R^*.$$
 (191)

At resonance, R^* is given by Eq (177) and so the electrical power at resonance when the crystal is in vacuo P_{0R} or in a fluid P_{1R} is given by

$$P_{0R} = P_{1R} = \frac{1}{2}V_0^2 / R_2 \tag{192}$$

where the value of the resistance, R_2 is, of course, different when the crystal is in vacuo from when it is in a fluid.

The bandwidth B_0^* for the crystal in vacuo is the difference between the two frequencies $\omega_{0+}^* (> \omega_{0R}^*)$ and $\omega_{0-}^* (< \omega_{0R}^*)$ where the power is (arbitrarily but

conventionally) $P_{0R}/2$: it is related to the quality factor Q_0^* , where it is assumed that $Q_0^* \gg 1$, by

$$B_0^* = \omega_{0+}^* - \omega_{0-}^* = \omega_{0R}^* / Q_0^*.$$
(193)

Similarly, the bandwidth B_1^* for the crystal in a fluid is the difference between the two frequencies ω_{1+}^* (> ω_{1R}^*) and ω_{1-}^* (< ω_{1R}^*) where the power is $P_{1R}/2$: it is related to the quality factor Q_1^* , where it is assumed that $Q_1^* \gg 1$, by

$$B_1^* = \omega_{1+}^* - \omega_{1-}^* = \omega_{1R}^* / Q_1^*.$$
(194)

Thus, if $P = P_{0\pm} = \frac{1}{2}P_{0R}$ when $\omega^* = \omega_{0+}^*$ or $\omega^* = \omega_{0-}^*$ and $P = P_{1\pm} = \frac{1}{2}P_{1R}$ when $\omega^* = \omega_{1+}^*$ or $\omega^* = \omega_{1-}^*$

$$P_{0\pm} = P_{1\pm} = \frac{1}{4}V_0^2/R_2 \tag{195}$$

and so

$$R^* = 2R_2 \tag{196}$$

and the current $A_{\rm rms}$ is a factor of $\left(1/\sqrt{2}\right)$ smaller than its value at resonance. Hence, using Eq. (173)

$$\Sigma = \pm R_2. \tag{197}$$

For notational convenience, let $\omega_{0\pm}^*$ denote $\omega_{0\pm}^*$ or $\omega_{0\pm}^*$ and let $\Delta \omega_{0\pm}^*$ denote $\Delta \omega_{0\pm}^*$ or $\Delta \omega_{0\pm}^*$ where

$$\Delta \omega_{0+}^* = \omega_{0+}^* - \omega_{0R}^* \tag{198}$$

and

$$\Delta \omega_{0-}^* = \omega_{0-}^* - \omega_{0R}^* \tag{199}$$

so that, combining Eqs. (198) and (199)

$$\Delta \omega_{0\pm}^* = \omega_{0\pm}^* - \omega_{0R}^*.$$
(200)

Then, using Eqs. (164) and (165) with k replaced by K because k=0 when the crystal is in vacuo,

$$\pm 1 = \frac{\left(Z_{2i}/Z_{1}\right) + \frac{1}{2\pi}\left\{\left(\Delta\omega_{0\pm}^{*}/\omega_{0R}^{*}\right) + \frac{1}{2(K/\rho_{c}I)\right\}}{\left(Z_{2r}/Z_{1}\right) + \frac{1}{2}\Gamma_{r}L}.$$
(201)

Using Eqs. (135) and (146) with k replaced by K and noting that $\Gamma_r \ll \Gamma_i$, it follows from Eq. (155) that

$$\frac{Z_2}{Z_1} = \frac{(1+i)\pi(K/\rho_c I)(\omega_{0\pm}^*/\omega_{0R}^*)(R/L)}{4\sqrt{(1+(K/\rho_c I))}}$$
(202)

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so, using Eq. (73) and since $K / (\rho_c I) \ll 1$

$$Z_{2r}/Z_1 = Z_{2i}/Z_1 = \frac{1}{2} \left(\frac{K}{\rho_c R^4} \right) \left(\omega_{0\pm}^* / \omega_{0R}^* \right) \left(\frac{R}{L} \right).$$
(203)

Using Eqs. (112), (117) and (73) with k replaced by K

$$\Gamma_{\rm r}L = \frac{1}{2}\omega_{0\pm}^* K C_{\rm m}L / \sqrt{\left(\rho_{\rm c}I C_{\rm m}\right)} = \frac{1}{2}\omega_{0\pm}^* K \sqrt{C_{\rm m}}L / \sqrt{\left(\rho_{\rm c} \frac{1}{2}\pi R^4\right)}$$
(204)

whence, using Eq. (135)

$$\Gamma_{\rm r}L = \frac{1}{2}\omega_{0\pm}^{*}\left(KL/\sqrt{\left(\rho_{\rm c}^{1}/2\pi R^{4}\right)}\right)\left(\pi/\left(\omega_{0\rm R}^{*}L\sqrt{\left(\rho_{\rm c}^{1}/2\pi R^{4}\right)}\right)\right)$$
(205)
= $\left(\omega_{0\pm}^{*}/\omega_{0\rm R}^{*}\right)(K/\rho_{\rm c}R^{4}).$

Thus, since $\omega_{0+}^* = \omega_{0R}^*$ to leading order

$$Z_{2r}/Z_1 = Z_{2i}/Z_1 = \frac{1}{2} (K/\rho_c R^4)(R/L)$$
(206)

and

$$\Gamma_{\rm r}L = \left(K/\rho_{\rm c}R^4\right). \tag{207}$$

Thus Eq. (201) becomes, using Eq. (73)

$$\pm 1 = \frac{\{[1/2(K/\rho_{c}R^{4})((R/L) + 1)] + 1/2\pi(\Delta\omega_{0\pm}^{*}/\omega_{0R}^{*})\}}{[1/2(K/\rho_{c}R^{4})((R/L) + 1)]}$$
(208)

whence

$$\Delta \omega_{0\pm}^* = -\omega_{0R}^* (1 - (\pm 1))(K/\pi \rho_c R^4)(1 + (R/L))$$
(209)

so $\Delta \omega_{0\pm}^* \leq 0$ and $\left| \Delta \omega_{0\pm}^* \right| / \omega_{0R}^* \ll 1$ since $K/(\rho_c I) \sim K/(\rho_c R^4) \ll 1$ so $\omega_{0\pm}^* = \omega_{0R}^*$ to leading order (proving consistency). It follows that

$$B_0^* = 2\omega_{0R}^* \left(K/\pi \rho_c R^4 \right) (1 + (R/L))$$
(210)

which can be rearranged to give

$$K = \frac{\left(B_0^*/\omega_{0R}^*\right)\pi\rho_c R^4}{2(1+(R/L))}$$
(211)

which can be used to determine K. Note that it follows from Eq. (193) and Eq. (211) that $Q_0^* \sim \rho_c R^4/K \gg 1$, as assumed (proving consistency).

If the crystal is immersed in a fluid, then K is replaced by (k + K), B_0^* is replaced by B_1^* and ω_{0R}^* is replaced by ω_{1R}^* in Eqs (210) and (211). Hence

$$B_1^* = 2\omega_{1R}^* \frac{(k+K)}{\pi\rho_c R^4} \left[(1+(R/L)) \right]$$
(212)

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and

$$k + K = (B_1^* / \omega_{1R}^*) \frac{\pi \rho_c R^4}{2(1 + (R/L))}$$
(213)

whence, eliminating K using Eq. (211)

$$k = \frac{\left[(B_1^*/\omega_{1R}^*) - (B_0^*/\omega_{0R}^*)\right]}{2(1 + (R/L))} \pi \rho_c R^4.$$
(214)

It follows from Eq. (214) using Eq. (22) that to leading order

$$\mu = \frac{\rho_{\rm c}^2 R^2 \omega_{\rm 1R}^* \left[(B_1^* / \omega_{\rm 1R}^*) - (B_0^* / \omega_{\rm 0R}^*) \right]^2}{8\rho (1 + (R/L))^2}$$
(215)

Note that Eq. (215) is, like Eq. (182), similar in form to Eq. (189). However, unlike Eq. (182), Eq. (215) is a practical working equation for viscosity since it does not involve the experimentally inaccessible ω_{0R} : all parameters on the right-hand side of Eq. (215) can be measured directly. An alternative form of Eq. (215) can be obtained by noting that the mass of the crystal, M_c , is given by

$$M_{\rm c} = \rho_{\rm c} \pi R^2 L \tag{216}$$

and the total surface area of the crystal (including its ends) S_c is given by

$$S_{\rm c} = 2\pi R L (1 + (R/L)).$$
 (217)

Thus, it follows from Eq. (215) that

$$\mu = \frac{1}{2\omega_{1R}^*} \left(M_c / S_c \right)^2 \left[(B_1^* / \omega_{1R}^*) - (B_0^* / \omega_{0R}^*) \right]^2 / \rho.$$
(218)

Note that it follows from Eqs. (194) and (214) using Eq. (22) that $Q_1^* \sim \rho_c R / \sqrt{\rho \mu / \omega_{0R}^*}$ so the fact that $\Delta \omega_0 / \omega_{0R} \ll 1$ and $\Delta \omega_1 / \omega_{1R} \ll 1$ implies that the resonant frequencies of the crystal in vacuo and in a fluid are not very different and in turn that $Q_1^* \gg 1$, as assumed (proving consistency). Moreover, it is clear that $Q_0^* > Q_1^*$ so $Q_0^* \gg 1$, as assumed (again proving consistency). As a result, it follows that the conditions under which Eq. (218) holds are precisely the same as those under which Eq. (189) holds. In addition, however, in order not to compromise the accuracy with which viscosity can be measured, it is necessary that:

$$(B_1^*/\omega_{1R}^*) \gg (B_0^*/\omega_{0R}^*).$$
 (219)

Note that *K* can be eliminated between Eqs. (185) and (211) using Eq. (73) to yield

$$\omega_{0R} = \omega_{0R}^* / \left(1 - \frac{1}{2} \left(\frac{B_0^*}{\omega_{0R}^*} \right) \right)$$
(220)

so ω_{0R} can be eliminated from Eq. (189) to yield

$$\mu = \frac{\rho_c^2 R^2 \omega_{1R}^* (\omega_{0R}^* - \omega_{1R}^*)^2 (1 - \frac{1}{2} (B_0^* / \omega_{0R}^*))^2}{2\rho \omega_{0R}^{*2} (1 + (R/L))^2}$$
(221)

or

$$\mu = \left(\frac{M_{\rm c}}{S_{\rm c}}\right)^2 \frac{2\omega_{\rm 1R}^* \left(\omega_{\rm 0R}^* - \omega_{\rm 1R}^*\right)^2 (1 - 1/2(B_0^*/\omega_{\rm 0R}^*))^2}{\rho \omega_{\rm 0R}^{*2}}.$$
 (222)

This is a working equation for the viscosity in terms of resonant frequencies in which all terms on the right-hand side can be measured directly.

6 Effects of Departures from the Ideal Model of the Viscometer

We have already considered the major departure of the viscometer from the ideal model of it by allowing there to be losses in the crystal itself and its support. However, there are several other possible effects which we should consider in order either to be able to apply a correction to the working equations for the viscometer or to render them negligible by design.

6.1 Ellipticity

It is always possible that the quartz crystal departs from the exact cylindrical shape assumed. Thus, we suppose the quartz crystal is a right cylinder of (weakly) elliptical (as opposed to circular) cross-section with major (or respectively minor) radius *A* and minor (or respectively major) radius *B* (thus A = R = B if the crystal is of circular cross-section). In cylindrical polar coordinates $\{r, \theta, z\}$, the surface of the crystal is defined by

$$\left(r^2/A^2\right)\cos^2(\theta-\Theta) + \left(r^2/B^2\right)\sin^2(\theta-\Theta) = 1$$
(223)

where the radius A is oriented at an angle Θ to the Y-direction.

We define the ellipticity, *e*, as

$$e = 1 - (B/A)$$
 (224)

where $|e| \ll 1$ and e = 0 corresponds to a crystal of circular cross-section. Now consider two identical crystals of (weakly) elliptical cross-section, the first with B < A and

$$B/A = 1 - e^* \tag{225}$$

so that

$$e = e^* \tag{226}$$

and the second (the same as the first but with the major and minor radii rotated by $\pm \frac{1}{2} \pi$) with A < B and

$$A/B = 1 - e^*$$
(227)

so that

$$e = -e^* - e^{*2} - e^{*3} + O(e^{*4}).$$
(228)

If the two crystals are surrounded by the same fluid with all conditions identical, other than the reciprocal orientations of the major and minor radii, then the two systems are entirely equivalent and have identical resonant frequencies ω_{0R}^* and ω_{1R}^* . Since $|e| \ll 1$, we assume that $\omega_{\#R}^*$ (where #=0 or 1) can be expanded in a power series as follows

$$\omega_{\#R}^* = \omega_{\#R0} + e\omega_{\#R1} + e^2\omega_{\#R2} + e^3\omega_{\#R3} + O(e^4).$$
(229)

Clearly, $\omega_{0R0} = \omega_{0R}$ and $\omega_{1R0} = \omega_{1R}$ for a crystal of circular cross-section. Expanding $\omega_{\#R}^*$ using Eq. (226) yields

$$\omega_{\#R}^*(e^*) = \omega_{\#R0} + e^*\omega_{\#R1} + e^{*2}\omega_{\#R2} + e^{*3}\omega_{\#R3} + O(e^{*4})$$
(230)

and expanding $\omega_{\#R}^*$ using Eq. (228) yields

$$\omega_{\#R}^{*} \left(-e^{*} - e^{*2} - e^{*3} + O(e^{*4}) \right) = \omega_{\#R0} - \left(e^{*} + e^{*2} + e^{*3} \right) \omega_{\#R1} + \left(e^{*2} + 2e^{*3} \right) \omega_{\#R2} - e^{*3} \omega_{\#R3} + O(e^{*4})$$
(231)

whence, equating coefficients of like powers of e^* , Eqs. (230) and (231) together yield

$$\omega_{\#R1} = 0$$

$$\omega_{\#R3} = \omega_{\#R2}.$$
(232)

This implies that ellipticity (ie non-circularity) has no effect on the resonant frequencies to first order, i.e. O(e): the only effect of ellipticity is at higher order. Note that, conventionally, the eccentricity e^{cc} of an ellipse is defined as

$$e^{cc} = \sqrt{\left(1 - \left(\frac{B^2}{A^2}\right)\right)}$$
 (233)

where B < A to give a real value of e^{cc} . Clearly, e^{cc} is related to e as follows

$$e^{cc} = \sqrt{(2e)} \left(1 - \frac{1}{4}e + O(e^2) \right) \approx \sqrt{2e}.$$
 (234)

but use of the ellipticity instead of the eccentricity greatly simplifies the reciprocity argument. It is generally possible to arrange that the ellipticity of a crystal is such that its effect can be rendered negligible.

6.2 Surface Roughness

Various causes, such as the crystal production or the way the electrodes are attached to the crystal, may mean that the surface of the crystal is not perfectly smooth. If the surface roughness is characterized by a linear dimension l_r (where $l_r \ll R$) then, in order that roughness does not have a significant effect on the behavior of the crystal, it is necessary that the roughness is insignificant compared with the shear layer thickness *d*, i.e.

$$l_{\rm r} \ll d \sim R / \sqrt{\Omega} = \sqrt{\mu / (\rho \omega_{0R})}.$$
 (235)

It is a matter of manufacture and design to ensure that this condition is met. Table 2 shows that if the roughness is at the level of optical wavelengths $(0.5\mu m)$, then for typical crystals used and for the fluids usually studied to date $l_r \sqrt{(\rho \omega_{0R})/\mu} \sim 10^{-1} - 10^{-2}$.

6.3 Containing Vessel

The crystal is immersed in a fluid, the viscosity of which is to be determined and the fluid must be held within a vessel (perhaps pressurized). If L^* denotes the typical distance between the wall of the containing vessel and all surfaces of the crystal (at r = R and at z = 0 and at z = L) then the presence of the walls of the containing vessel does not significantly interfere with the behavior of the crystal if the thickness, d, of the shear layer is very small compared with L^* i.e. if $d/L^* \sim (R/L^*)/\sqrt{\Omega} \ll 1$ i.e.

$$R/L^* \ll 1 \text{ or } \sim 1$$
 (236)

since $\sqrt{\Omega} \gg 1$. This can readily be achieved by a suitable design.

6.4 Variable Fluid Properties

The viscosity, μ , and density, ρ , both vary with pressure, p, and temperature, T. As already noted, the flow induces pressure fluctuations in the fluid of order $\rho\omega^2\epsilon^2 R^2$ so the effect of pressure variations on the measured viscosity, μ , is negligible provided

$$\rho \omega_{0R}^2 \epsilon^2 R^2 |\partial \mu / \partial p| / \mu \ll 1 \tag{237}$$

and the effect of pressure variations on the density is negligible provided that

$$\rho \,\omega_{0R}^2 \epsilon^2 R^2 |\partial \rho / \partial p| \,/\rho \ll 1 \tag{238}$$

and provided the Mach number Ma « 1, as already noted.

For an imposed (or adventitious) temperature difference ΔT^* in the system, the effect of temperature variations on the viscosity is negligible provided that

$$\Delta T * \left| \frac{\partial \mu}{\partial T} \right| / \mu \ll 1 \tag{239}$$

and the effect of temperature variations on the density, ρ , is negligible provided that

$$\Delta T^* |\partial \rho / \partial T| / \rho \ll 1. \tag{240}$$

Here, $|\partial \mu / \partial p|$, $|\partial \rho / \partial p|$, $|\partial \mu / \partial T|$ and $|\partial \rho / \partial T|$ are all evaluated at the ambient temperature of the fluid. Table 2 shows these conditions are easily satisfied.

6.5 Decay of Initial Transient

In order for the transient that occurs on start-up of the flow to decay sufficiently for Eq. (5) to hold, a time t^* must elapse that is much larger than the characteristic time, $(d_2 \rho/\mu)$ for a shear wave to propagate through the shear layer of thickness d. Since $d \sim R/\sqrt{\Omega}$ where Ω is given by Eq. (10), the start-up transient has decayed sufficiently if

$$1/t^*\omega_{0R} \ll 1.$$
 (241)

Again, this is a condition easily satisfied in practice as Table 2 shows.

6.6 Edges

The moments $M|_L$ and $M|_0$ exerted on the ends of the crystal by the fluid are given by Eqs. (32) and (33) respectively, assuming that rippling of the ends of the crystal at z=0 or z=L has a negligible effect. An additional correction should, however, be made in the vicinity of what might be termed the edges of the cylinder where r=Rand z=0 or z=L. The shear stress exerted by the crystal on the fluid $\sigma_{r\theta}$ is given by Eq. (18) in the region where $0 \le z \le L$ and r=R. The shear stress exerted by the crystal on the fluid $\sigma_{z\theta}$ is given by Eq. (30) in the region where z=L and $0 \le r \le R$. At the edge at z=L and r=R, Eqs. (18) and (30) can be combined to give

$$\sigma_{n\theta}|_{R,L} = (1-i)\sqrt{(1/2\,\Omega)}\,\mu\,\omega\,\varepsilon\,\exp\left(i\omega t\right) \tag{242}$$

where *n* denotes the outer normal to the surface of the crystal. Clearly, Eq. (242) also holds at the other corner at z=0 and r=R. Thus, the shear stress $\sigma_{n\theta}|_{R,L}$ giving rise to the moment and hence the loading by the fluid on the cylinder is continuous over the entire the surface of the cylinder, though its gradient is discontinuous at the edges. Moreover, $\sigma_{n\theta}|_{R,L} \sim \mu\omega\epsilon\sqrt{\Omega}$ so the thickness of the shear layer $d \sim R/\sqrt{\Omega} \ll 1$ everywhere on the crystal. Thus, although nothing has been deduced about the matching region that must exist in the vicinity of the edges, the extent of that matching region must be O(d) in both the *r*- and *z*-directions. Thus, the overall effect of the corners is negligible provided $d \ll R$ and $d \ll L$ which is guaranteed if $\sqrt{\Omega} \gg 1$ and $R/L \ll 1$ or ~ 1 .

6.7 Standing Waves

Standing (acoustic) waves can arise if any of the overall dimensions of the system $(2R, L \text{ and } L^*)$ is an integer multiple of half of the wavelength λ' of the torsional oscillations of the crystal. Now $\lambda' = 2\pi c/\omega_{1R}$ (where *c* is the speed of sound) so, if *L'* denotes 2R, L and L^* , standing waves can be avoided if, for all integer *n*

$$n\pi c/\omega_{1R} \neq L'. \tag{243}$$

But $\omega_{1R} = \omega_{0R} + \Delta \omega_1$ so, substituting from Eq. (181) for $\Delta \omega_1$, standing waves can be avoided if, for all integer *n*

$$L'\omega_{1R}/(\pi c) = [L'\omega_{0R}/(\pi c)] [1 - (2/(\rho_c R))\sqrt{(1/2\rho\mu/\omega_{0R})} (1 + (R/L))] \neq n.$$
(244)

Careful operation can secure this condition.

6.8 Viscous Dissipation

The power dissipated by viscous action P_v is given by the time-average over a cycle of oscillation of the integral over the total surface area of the crystal of the product of the real part, denoted R(), of the speed u_{θ} of the cylinder and the real part of the shear stress exerted by the fluid on the cylinder $-\sigma_{r\theta}$ on the curved surface of the cylinder or $-\sigma_{z\theta}$ on the two planar ends of the cylinder. Over the curved surface of the cylinder $0 \le z \le L$ and r = R, it follows from Eq. (18) that

$$R(u_{\theta}|_{R}) = R(i\omega\varepsilon R \exp(i\omega t)) = -\omega\varepsilon R \sin(\omega t)$$
(245)

and it follows from Eq. (24) that

$$R(\sigma_{r\theta}|_{R}) = R((1-i)\sqrt{(1/2\Omega)}\mu\omega\varepsilon\exp(i\omega t)) = \sqrt{(1/2\Omega)}\mu\omega\varepsilon\left[\cos(\omega t) + \sin(\omega t)\right].$$
(246)

Similarly, over the planar surface of the cylinder at $0 \le r \le R$ and z=0 or z=L, it follows from Eq. (24) that

$$R(u_{\theta}|_{0}) = R(u_{\theta}|_{L}) = R(i\omega\varepsilon r \exp(i\omega t)) = -\omega\varepsilon r \sin(\omega t)$$
(247)

and it follows from Eq. (30) that

$$R(\sigma_{z\theta}|_{0}) = R(\sigma_{z\theta}|_{L}) = R\left\{ (1-i)\sqrt{(1/2\Omega)}\mu\omega\,\epsilon\,(r/R)\,\exp(i\omega t) \right\}$$

= $\sqrt{(1/2\Omega)}\mu\omega\,\epsilon\,(r/R)[(\cos(\omega t)\,+\,\sin(\omega t)].$ (248)

Thus, the time-varying power $P_{\rm v}(t)$ is given by

$$P_{v}(t) = \omega \varepsilon \sin(\omega t) \sqrt{(1/2 \Omega)} \mu \omega \varepsilon (\cos(\omega t) + \sin(\omega t)) \left[2\pi R^{2}L + (2/R) \int_{0}^{R} 2\pi r^{3} dr \right]$$
$$= \sqrt{(1/2 \Omega)} \mu \omega^{2} \varepsilon^{2} 2\pi R^{2}L \left[1 + R/2L \right] \sin(\omega t) \left[\cos(\omega t) + \sin(\omega t) \right]$$
(249)

so the time averaged power is

$$P_{\nu} = \frac{1}{2}\sqrt{(1/2\Omega)} \,\mu \,\omega^2 \epsilon^2 2 \,\pi \,R^2 L \,(1 + \frac{1}{2}(R/L)). \tag{250}$$

The term $[1 + \frac{1}{2}(R/L)]$ in Eq. (250) is a result of two contributions to the viscous dissipation at the surface of the crystal: the first from its curved surface at r=R and the second, a factor $\frac{1}{2}(R/L)$ of the size of the first, from its ends at z=0 and z=L. For typical crystals the total dissipation amounts to ~ 10^{-9} W.

To obtain an upper limit of the effect of this power it can be assumed that this amount is dissipated in the thin fluid shear layer of thickness d at the surface of the cylinder and nowhere else. In which case, the temperature rise of the fluid per unit time, $(dT/dt)_{visc}$ in that layer caused by this amount of heat is given approximately by

$$(\mathrm{d}T/\mathrm{d}t)_{\mathrm{visc}} \approx \frac{P_{\mathrm{v}}}{2\pi R dL \rho C_p}.$$
 (251)

This amounts to approximately 2×10^{-7} K s⁻¹ for liquid Hexane in a typical installation. For the dilute gas state of Methane, the equivalent calculation leads to a rate of temperature rise of 3×10^{-6} K s⁻¹. In neither case would such a rise lead to significant changes in the properties of the fluid being measured.

7 Conclusions

The rigorous analysis of the torsional quartz crystal viscometer presented here has enabled us to derive two working equations for the measurement of the viscosity of a fluid surrounding the crystal from parameters that can be determined with high precision using modern instrumentation. The first equation which uses measured bandwidths, B_i^* and resonant frequencies, ω_{iR}

$$\mu = \frac{1}{2\omega_{1R}^*} \left(M_c / S_c \right)^2 \left[(B_1^* / \omega_{1R}^*) - (B_0^* / \omega_{0R}^*) \right]^2 / \rho$$
(252)

has often been employed [1-17]. The second equation, which uses resonant frequencies only, is

$$\mu = \left(\frac{M_{\rm c}}{S_{\rm c}}\right)^2 \frac{2\omega_{1\rm R}^* (\omega_{0\rm R}^* - \omega_{1\rm R}^*)^2 (1 - \frac{1}{2} (B_0^* / \omega_{0\rm R}^*))^2}{\rho \omega_{0\rm R}^{*2}}.$$
 (253)

Both working equations are valid subject to a number of clear criteria which can be satisfied by appropriate and practical design of the instrument. In Part II of this work [19] we examine the two working equations with respect to the detailed and careful experimental work of three groups who have employed the torsional crystal oscillator for measurements of the viscosity of fluids in both gaseous and liquid states. **Acknowledgements** The authors are grateful to Arno Laesecke, Carlos Castro, Fernando Santos, Dwain Diller, Karsten Meier and Clemens Junker for discussions over many years that have encouraged us to continue with this work and also to many of them for the provision of their experimental data.

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